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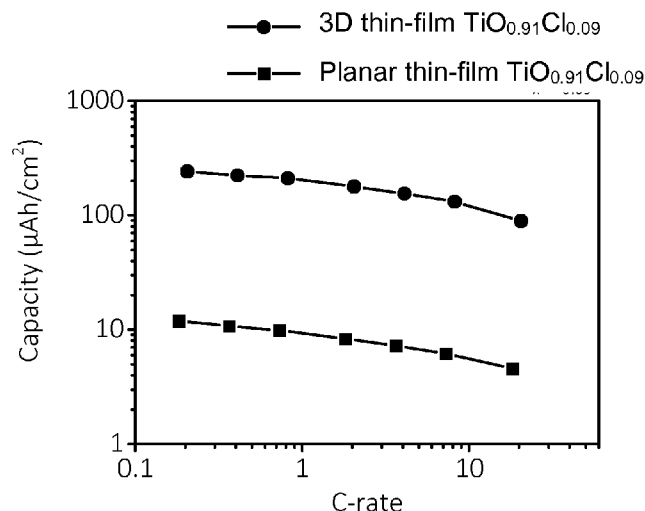


FIG 8

(57) Abstract: Ion insertion battery electrode and method of fabrication The present disclosure relates to electrode layers of ion insertion type batteries and to electrode layer materials wherein the electrode layer materials have a good electronic conductivity and a good ion conductivity, and wherein the electrode layers offer a good rate performance and a high storage capacity. The disclosure further relates to ion insertion type battery cells and batteries comprising such electrode layers, e.g. as an anode. The disclosure further relates to methods for forming such electrode layers and to methods for fabricating ion insertion type battery cells and batteries. Electrode layers according to the present disclosure comprise titanium oxide comprising chlorine and may be deposited by Atomic Layer Deposition at temperatures lower than 150°C.



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ION INSERTION BATTERY ELECTRODE AND METHOD OF FABRICATION

[0001] The present disclosure relates to ion insertion type batteries and to methods for fabricating ion insertion type batteries, such as for example Li-ion batteries.

5 [0002] More in particular, the present disclosure relates to electrodes and electrode layers for ion insertion type batteries and to methods for forming such electrodes and electrode layers. These electrode layers may for example be used as electrodes in thin-film batteries, in particle based batteries, in all-solid-state batteries, or in liquid electrolyte batteries.

10 [0003] A material that is receiving considerable attention as an electrode for ion insertion type batteries such as lithium-ion batteries is TiO_x , since it offers a high theoretical capacity (335 mAh/g or for anatase TiO_2 about 1280 mAh/cm³) and offers a potentially cheap, environmentally friendly and stable alternative to the current electrode materials. However, due to its low electronic conductivity and poor Li-ion conductivity it has a poor rate performance, which makes it unsuitable for practical applications.

15 [0004] To improve the rate performance methods such as doping, nanostructuring or nanosizing and the use of different TiO_x polymorphs are being investigated. Doping of the TiO_x material may lead to an improved electronic conductivity of the material and in addition the ion conduction (ion diffusion) may be facilitated. Such positive conductivity effects have been reported for Li-ion diffusion in anatase and spinel TiO_x based particles doped with cations and anions. Also, a reductive type of doping by H_2 has been proposed, giving rise to an enhanced electronic conductivity of anatase TiO_x and improved Li-ion storage kinetics, i.e. a higher rate of Li-ion insertion and extraction, with more capacity available at higher charging rates. Such hydrogen doping process is typically done at a temperature above 300°C, such as for example at 450°C, which makes it incompatible with amorphous TiO_x . Among the different strategies to improve the rate performance of TiO_x , the use of amorphous TiO_x instead of crystalline (e.g. anatase) TiO_x shows promising results. However, also in this case nanostructuring or the creation of composites such as TiO_x /carbon composites is necessary to achieve a good rate performance.

25 [0005] Nanosizing leads to a reduction of the diffusion path for ions and electrons, such that the storage capacity may be enhanced. There are several reports showing an improved storage capacity based on nanosizing strategies for amorphous TiO_x , such as for example the introduction of (meso)porosity in the amorphous TiO_x layers and the creation of nanotubes. For example, nanosizing of amorphous TiO_x may comprise forming nanotubes by anodization of titanium sheets.

30 [0006] The creation of nanocomposites based on amorphous TiO_x , such as for example an amorphous TiO_x /carbon nanocomposite (e.g. carbon-titania/titanate nanocomposite), may lead to improved ion insertion and extraction properties. For example, an amorphous TiO_x thin film may be deposited, such as for example by ALD (Atomic Layer Deposition), on carbon nanosheets. Although a high capacity per weight of TiO_x can be achieved using this approach, the volumetric capacity is rather low.

35 [0007] In general, nanosystems comprising for example nanoparticles, nanotubes or nanosheets, tend to be significantly more expensive than thin-film based systems. Further, in the context of ion insertion type batteries such as Li-ion batteries, due to an enhanced surface area per volume in nanostructures, parasitic capacity losses may increase as a result of degradation of the electrolyte at the electrode interface. This is a major drawback of using nanoscaled structures for battery applications. Aarik et al. (thin solid films, vol. 305, no 1-2, 1 august 1997, p. 270-273) discloses thin films of titanium oxide comprising chlorine grown by ALD. Their optical properties are investigated and they are not used to form electrodes.

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[0008] US 2011/052994 discloses a negative electrode for lithium-ion batteries comprising a film of titanium oxide comprising chlorine. This film is crystalline.

[0009] US 2015/086809 discloses a lithium-ion solid state battery deposited on a semiconductor substrate, in which a thin layer of pure titania is used in a negative electrode.

- 5 [0010] Chunmei Ban et al. (nanotechnology, vol. 24, no 42, 25 September 2013, p. 424002) discloses a method for fabricating TiO₂ layers for the negative electrode of lithium batteries via ALD.

[0011] It is an object of the present disclosure to provide electrode layer materials and electrode layers, such as for example thin-film electrode layers or (nano)particle based electrode layers, of ion insertion type
10 batteries wherein the electrode layers offer a good rate performance and a high storage capacity.

[0012] More in particular, it is an object of the present disclosure to provide electrode layers of ion insertion type batteries wherein the electrode layers offer a charging rate higher than 1C, and a capacity of at least 70% of the theoretical maximum capacity.

[0013] It is an object of the present disclosure to provide electrode layer materials and electrode layers, such as for example thin-film electrode layers or (nano)particle based electrode layers, of ion insertion type
15 batteries, wherein the electrode layer material has a good electronic conductivity and a good ion conductivity.

[0014] More in particular, it is an object of the present disclosure to provide electrode layer materials and electrode layers of ion insertion type batteries, wherein the electrode layer material has an electronic conductivity above 10⁻⁷ S/cm in the discharged state and an ion diffusivity above 10⁻¹⁴ cm²/s in the discharged state.

20 [0015] It is a further object of the present disclosure to provide methods for forming electrode layers for ion insertion type batteries wherein the electrode layer material offers a good rate performance and a high volumetric storage capacity.

[0016] Electrode layers according to embodiments of the present disclosure may be integrated in ion insertion type batteries, such as for example Li-ion, K-ion, Na-ion, Mg-ion or Al-ion batteries, the present
25 disclosure not being limited thereto.

[0017] The above objective is accomplished by a method and device according to the present disclosure.

[0018] In a first aspect, the disclosure is related to a negative electrode of an ion insertion battery cell comprising a negative electrode layer comprising a titanium oxide comprising chlorine being either amorphous or a mixture of an amorphous titanium oxide comprising chlorine and a crystalline titanium oxide comprising
30 chlorine, preferably with a ratio chlorine to titanium from 0.01 to 0.1, more preferably from 0.06 to 0.09, yet more preferably from 0.060 to 0.090 when measured by Rutherford Backscatter Spectroscopy. When a titanium oxide comprising chlorine is related to in the present disclosure, this may refer to a material of general formula TiO_xCl_y and preferably TiO_{2-y}Cl_y. In embodiments, y may be from 0.01 to 0.1, preferably from 0.06 to 0.09. In
35 embodiments, the titanium oxide layer comprising chlorine may have for general formula TiO_{2-y}Cl_y wherein y is from 0.01 to 0.1, preferably from 0.06 to 0.09. The thickness of an electrode layer according to embodiments of the present disclosure may for example be in the range between 5 nm and 2 micrometer, such as for example in the range between 100 nm and 1 micrometer.

[0019] Preferably, the negative electrode layer may be an amorphous electrode layer, wherein the titanium oxide comprising chlorine is in an amorphous state. In other embodiments of the present disclosure the negative
40 electrode layer may comprise a mixture of amorphous titanium oxide comprising chlorine and crystalline titanium oxide comprising chlorine.

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[0020] In embodiments of the present disclosure the negative electrode layer may be a thin-film electrode layer.

[0021] In embodiments of the present disclosure the negative electrode layer may be a (nano)particle based electrode layer.

5 [0022] A negative electrode layer according to embodiments of the present disclosure may have the function of an anode in the ion insertion type battery cell.

[0023] In a second aspect, the present disclosure relates to an insertion battery cell comprising a negative electrode in accordance with the first aspect.

10 [0024] In a third aspect, the present disclosure relates to an ion insertion type battery comprising at least one ion insertion battery cell in accordance with the second aspect.

[0025] In a fourth aspect the present disclosure relates to a method for forming a negative electrode of a thin-film ion insertion battery cell in accordance with the first aspect, wherein the method comprises depositing a thin film of titanium oxide comprising chlorine on a substrate by performing an Atomic Layer Deposition process wherein the deposition temperature is in the range between 50°C and 150°C, wherein TiCl₄ and H₂O are
15 used as precursors, and wherein the titanium oxide comprising chlorine is either amorphous or a mixture of an amorphous titanium oxide comprising chlorine and a crystalline titanium oxide comprising chlorine.

[0026] Depositing the thin film may comprise depositing the thin film on a planar substrate or on a non-planar substrate such as a 3D substrate. A 3D substrate is a structured substrate comprising 3D features, such as for example a plurality of high aspect-ratio micro-pillars, high aspect-ratio micro-trenches, a plurality of
20 nanowires, meshes, (nano)porous structures and/or three-dimensional scaffolds. The 3D features may be present in a regular pattern, such as e.g. a regular array, or they may be distributed randomly over the substrate.

[0027] In a fifth aspect, the present disclosure relates to a method for fabricating an ion insertion battery cell wherein the method comprises forming a negative electrode layer according to the fourth aspect.

[0028] The method for fabricating an ion insertion battery cell according to embodiments of the present
25 disclosure may comprise depositing the negative electrode layer on a layer stack comprising a first positive electrode layer and an electrolyte layer.

[0029] In a sixth aspect, the present disclosure relates to a method for fabricating an ion insertion battery comprising at least one ion insertion battery cell, the method comprising fabricating the at least one ion insertion battery cell by a method in accordance with the fifth aspect.

30 [0030] In seventh aspect, the present disclosure relates to a negative electrode obtainable by depositing a thin film of titanium oxide comprising chlorine on a substrate by performing an Atomic Layer Deposition process using TiCl₄ and H₂O precursors at a deposition temperature in the range between 50°C and 150°C, the titanium oxide comprising chlorine being either amorphous or a mixture of an amorphous titanium oxide comprising chlorine and a crystalline titanium oxide comprising chlorine. Such a titanium oxide comprising chlorine is
35 typically an electrically and ionically conductive material.

[0031] In an eight aspect, the present disclosure relates to the use of a layer of titanium oxide comprising chlorine in an ion insertion electrode, wherein the titanium oxide comprising chlorine is either amorphous or a mixture of an amorphous titanium oxide comprising chlorine and a crystalline titanium oxide comprising chlorine. The ion insertion electrode may for instance be an electrode of e.g. an ion insertion type battery cell or
40 an ion insertion type battery.

[0032] It is an advantage of an electrode layer according to embodiments of the present disclosure that it allows obtaining a high storage capacity without the need for nanostructuring or nanosizing and/or without the need for forming carbon nanocomposites. However, electrode layers according to embodiments of the present disclosure may be combined with nanostructuring approaches.

5 [0033] It is an advantage of methods according to embodiments of the present disclosure that they enable forming smooth electrode layers having a well-controlled thickness and a well-controlled Cl content.

[0034] It is an advantage of methods according to embodiments of the present disclosure that they allow forming thin-film electrode layers with good conformality, i.e. layers having a uniform thickness and exactly following the topography of the underlying substrate. Therefore, a method of the present disclosure may
1 0 advantageously be used for forming such layers on 3D structures (e.g. in a process for fabricating 3D battery architectures), such as for example on a structure comprising a plurality of high aspect-ratio micro-pillars, high aspect-ratio micro-trenches, a plurality of nanowires, meshes, (nano)porous structures and/or three-dimensional scaffolds. Due to the conformal deposition of the layers using an ALD based method according to embodiments of the present disclosure, the thickness of the layers is substantially the same on the 3D structures and in the
1 5 recesses between such structures as well as on the sides of such structures.

[0035] It is an advantage of methods according to embodiments of the present disclosure that they can be easily up-scaled. In advantageous embodiments of the present disclosure, spatial ALD may be used for forming the electrode layers. It is an advantage of spatial ALD as compared to temporal ALD that it allows faster deposition, e.g. a factor of 10 faster deposition, of the electrode layers. This results in a higher fabrication
2 0 throughput and potentially a lower cost. This allows potentially for roll-to-roll fabrication.

[0036] It is an advantage of methods according to embodiments of the present disclosure that a low deposition temperature is used, such as for example a deposition temperature in the range between 50°C and 150°C. It is an advantage of such low temperatures that the deposition of an electrode layer according to embodiments of the present disclosure is compatible with some solid-state electrolytes that are only functional
2 5 in the glassy state, such as for example LiPON or Li₂S-P₂S₅. The low deposition temperature used allows to prevent the crystallization of such materials, which is important for achieving the highest possible performance. In addition, it is an advantage of such low deposition temperature that it may mitigate oxidation of current collectors, or chemical (or structural) modification of other materials used in a battery stack.

[0037] It is an advantage of methods according to embodiments of the present disclosure that the as-deposited electrode layers are amorphous electrode layers, which may give rise to an enhanced storage capacity as compared to crystalline electrode layers. The electrode layers according to embodiments of the present disclosure may be used in an amorphous state in the battery. However, if desired, they may be transformed into a crystalline state, for example by performing an annealing step at a relatively low temperature, such as for example at about 300°C, the present disclosure not being limited thereto.

3 5 [0038] Particular and preferred aspects of the disclosure are set out in the accompanying independent and dependent claims. Features from the dependent claims may be combined with features of the independent claims and with features of other dependent claims as appropriate and not merely as explicitly set out in the claims.

[0039] The above and other characteristics, features and advantages of the present disclosure will become apparent from the following detailed description, taken in conjunction with the accompanying drawings, which
4 0 illustrate, by way of example, the principles of the disclosure. This description is given for the sake of example

only, without limiting the scope of the disclosure. The reference figures quoted below refer to the attached drawings.

[0040] Fig 1 shows a schematic cross section of a battery cell.

[0041] FIG 2 shows XPS measurement results illustrating the chlorine to titanium ratio (filled circles) and the oxygen to titanium ratio (filled squares) for thin ALD films of titanium oxide comprising chlorine in accordance with embodiments of the present disclosure, as a function of the ALD deposition temperature.

[0042] FIG 3 shows RBS measurement results showing the Cl/Ti ratio for thin ALD films of titanium oxide comprising chlorine in accordance with embodiments of the present disclosure, as a function of the ALD deposition temperature.

[0043] FIG 4 shows the potential-capacity curves as determined from charge / discharge measurements for 100 nm thick thin films of titanium oxide comprising chlorine at a C-rate of 0.4C in accordance with embodiments of the present disclosure for different Cl contents ($y = 0.06$; $y = 0.07$ and $y = 0.09$), and for a 35 nm thick amorphous TiO_2 layer at a C-rate of 1C.

[0044] FIG 5 shows the delithiation capacity as a function of C-rate as determined from charge / discharge measurements for 100 nm thick thin films of titanium oxide comprising chlorine in accordance with embodiments of the present disclosure for different Cl contents ($y = 0.06$; $y = 0.07$ and $y = 0.09$).

[0045] FIG 6 shows the volumetric delithiation capacity measured at a rate of 0.4 ($5.3 \mu\text{A}/\text{cm}^2$) as a function of the Cl content y for 100 nm thick layers of titanium oxide comprising chlorine formed in accordance with embodiments of the present disclosure.

[0046] FIG 7 shows the measured thickness of layers titanium oxide comprising chlorine deposited in accordance with a method of the present disclosure on a 3D substrate comprising a plurality of micro-pillars, as a function of the distance from the top of the micro-pillars.

[0047] FIG 8 shows the measured rate performance of planar (filled squares) and 3D (filled circles) thin film layers of titanium oxide comprising chlorine in a ratio Cl to Ti of 0.09 deposited in accordance with a method of the present disclosure. The capacity per footprint area is given as a function of C-rate.

[0048] FIG 9 shows the measured lithiation and delithiation capacity per footprint area as a function of charge/discharge cycles of a 100 nm thick layer of titanium oxide comprising chlorine deposited on silicon micropillars in accordance with a method of the present disclosure, measured at 2C ($0.53 \text{ mA}/\text{cm}^2$ per footprint area).

[0049] Fig 10 shows the XPS spectrum in the energy range for Ti-Cl binding of films grown according to embodiments of the present invention.

[0050] Fig 11 shows electrochemical characterization of electrode prepared according to embodiments of the present invention and of a comparative amorphous TiO_2 film.

[0051] Fig 12 shows the storage capacity of an electrode according to the present invention and of comparative electrodes.

[0052] Fig 13 shows SEM micrographs of a: pillars (top view); and pillars coated according to embodiments of the present invention (b: tilted top view; c: cross-section).

[0053] Fig 14 shows electrochemical characteristics of planar electrodes compared to 3D electrodes according to embodiments of the present invention.

[0054] Fig 15 compares the footprint capacity (top left), the active material capacity (top right), and the 3D electrode capacity of electrodes according to embodiments of the present invention with comparative electrodes.

[0055] In the different figures, the same reference signs refer to the same or analogous elements.

[0056] The present disclosure will be described with respect to particular embodiments and with reference to certain drawings but the disclosure is not limited thereto but only by the claims. The drawings described are only schematic and are non-limiting. In the drawings, the size of some of the elements may be exaggerated and not drawn on scale for illustrative purposes. The dimensions and the relative dimensions do not correspond to actual reductions to practice of the disclosure.

[0057] The terms first, second, third and the like in the description and in the claims, are used for distinguishing between similar elements and not necessarily for describing a sequence, either temporally, spatially, in ranking or in any other manner. It is to be understood that the terms so used are interchangeable under appropriate circumstances and that the embodiments of the disclosure described herein are capable of operation in other sequences than described or illustrated herein.

[0058] Moreover, the terms top, bottom, over, under and the like in the description and the claims are used for descriptive purposes and not necessarily for describing relative positions. It is to be understood that the terms so used are interchangeable under appropriate circumstances and that the embodiments of the disclosure described herein are capable of operation in other orientations than described or illustrated herein.

[0059] It is to be noticed that the term “comprising”, used in the claims, should not be interpreted as being restricted to the means listed thereafter; it does not exclude other elements or steps. It is thus to be interpreted as specifying the presence of the stated features, integers, steps or components as referred to, but does not preclude the presence or addition of one or more other features, integers, steps or components, or groups thereof. Thus, the scope of the expression “a device comprising means A and B” should not be limited to devices consisting only of components A and B. It means that with respect to the present disclosure, the only relevant components of the device are A and B.

[0060] Reference throughout this specification to “one embodiment” or “an embodiment” means that a particular feature, structure or characteristic described in connection with the embodiment is included in at least one embodiment of the present disclosure. Thus, appearances of the phrases “in one embodiment” or “in an embodiment” in various places throughout this specification are not necessarily all referring to the same embodiment, but may. Furthermore, the particular features, structures or characteristics may be combined in any suitable manner, as would be apparent to one of ordinary skill in the art from this disclosure, in one or more embodiments.

[0061] Similarly, it should be appreciated that in the description of exemplary embodiments of the disclosure, various features of the disclosure are sometimes grouped together in a single embodiment, figure, or description thereof for the purpose of streamlining the disclosure and aiding in the understanding of one or more of the various inventive aspects. This method of disclosure, however, is not to be interpreted as reflecting an intention that the claimed disclosure requires more features than are expressly recited in each claim. Rather, as the following claims reflect, inventive aspects lie in less than all features of a single foregoing disclosed embodiment. Thus, the claims following the detailed description are hereby expressly incorporated into this detailed description, with each claim standing on its own as a separate embodiment of this disclosure.

[0062] Furthermore, while some embodiments described herein include some but not other features included in other embodiments, combinations of features of different embodiments are meant to be within the scope of the disclosure, and form different embodiments, as would be understood by those in the art. For example, in the following claims, any of the claimed embodiments can be used in any combination.

[0063] In the description provided herein, numerous specific details are set forth. However, it is understood that embodiments of the disclosure may be practiced without these specific details. In other instances, well-known methods, structures and techniques have not been shown in detail in order not to obscure an understanding of this description.

5 [0064] The following terms are provided solely to aid in the understanding of the disclosure.

[0065] In the context of the present disclosure, a battery cell is a structure comprising two electrode layers with an electrolyte layer in between, i.e. a structure comprising an first electrode layer / electrolyte layer / second electrode layer stack. A battery may comprise a single battery cell or it may comprise a plurality of, e.g. at least two, battery cells. A battery may comprise two or more battery cells connected in series or in parallel, or a
10 combination of series and parallel connected battery cells.

[0066] In the context of the present disclosure, an ion insertion type battery is a battery comprising electrodes that can accept or release cations or anions during operation of the battery. Ion insertion type batteries can rely on the insertion/extraction of only one cation element, multiple cation elements, only anions or a mixture of anion and cation elements. An ion insertion type battery further comprises an electrolyte that allows for ionic
15 conduction of the respective ion used, while being (electro)chemically stable with regard to the used electrode material.

[0067] In a rechargeable battery, each of the electrodes has a first polarity during the discharge (i.e. battery operation) and a second, opposite polarity during charging. Technically speaking however, the negative electrode is the anode during the discharge and the cathode during charging. Vice versa, the positive electrode is the cathode
20 during discharge and the anode when charging the battery. In the context of the present disclosure, the terminology of the discharge (i.e. battery operation) is used. Herein further, with anode the negative electrode is meant and with cathode the positive electrode is meant. Through the disclosure, when referred to 'anode material' it is meant the negative electrode material and when referred to 'cathode material' it is meant the positive electrode material.

25 [0068] As used herein, NC refers to a charge or discharge rate which is N times the rated current capacity C of a battery. N is a number; it can be a natural number or a fraction.

[0069] In the context of the present disclosure, a thin film is a thin layer or thin coating having a thickness in the range between 10 nm and 10 micrometer. A thin-film battery is a battery composed of thin-film layers, i.e. a battery wherein the cathode layer, the electrolyte layer and the anode layer are thin layers with a thickness in
30 the range between 10 nm and 10 micrometer.

[0070] In the context of the present disclosure, nanoparticles are particles having a diameter in the range between 1 nm and 500 nm, typically between 10 nm and 100 nm. The nanoparticles can for example have a particular shape such as a spherical, cubic, octahedral or coned shaped, or they can have a random shape. A (nano)particle based electrode layer is an electrode layer containing (nano)particles, and optionally additives such
35 as a binder and and/or an electron conductor such as e.g. carbon black.

[0071] The disclosure will now be described by a detailed description of several embodiments of the disclosure. It is clear that other embodiments of the disclosure can be configured according to the knowledge of persons skilled in the art without departing from the true spirit or technical teaching of the disclosure, the disclosure being limited only by the terms of the appended claims.

40 [0072] In the further description, the present disclosure is mainly described for thin-film solid-state Li-ion batteries, but the present disclosure is not limited thereto. For example, electrode layers and methods according

to embodiments of the present disclosure may also be used in the context of particle based batteries and/or in the context of liquid electrolyte batteries. Further, electrode layers and methods according to embodiments of the present disclosure may also be used in other ion insertion type batteries, such as for example Mg-ion, K-ion, Na-ion or Al-ion batteries.

5 **[0073]** FIG 1 shows a schematic cross section of a thin-film battery cell 100. It comprises a stack of a first current collector layer 11, a first electrode layer 12, an electrolyte layer 13, a second electrode layer 14 and a second current collector layer 15. This stack may be provided on a substrate 10. The first electrode layer 12 may be a negative electrode layer or anode layer and the second electrode layer 14 may be a positive electrode layer or cathode layer or vice versa, the first electrode layer 12 may be a positive electrode layer or cathode layer and
10 the second electrode layer 14 may be a negative electrode layer or anode layer.

[0074] In the further description, it is assumed that the first electrode layer 12 is a positive electrode layer and the first current collector layer 11 is a positive current collector layer and it is assumed that the second electrode layer 14 is a negative electrode layer and the second current collector layer 15 is a negative collector layer.

15 **[0075]** An electrode layer according to embodiments of the present disclosure may advantageously be used as the second (negative) electrode layer 14 in the structure shown in FIG 1, i.e. it may advantageously be deposited after having deposited a first (positive) current collector layer 11, a first (positive) electrode layer 12 and an electrolyte layer 13 on the substrate 10. As further described, an electrode layer according to embodiments of the present disclosure may advantageously be an amorphous layer. By depositing the electrode layer according
20 to embodiments of the present disclosure after having deposited the other layers of the layer stack, the risk of crystallization of the amorphous electrode layer, e.g. crystallization to the anatase phase, may be avoided. If the amorphous electrode layer would be deposited first, there might be a risk that such crystallization would occur as a result of the deposition of the other layers of the stack, which may require annealing. Crystallization of the amorphous electrode layer would result in a loss of capacity and is therefore preferably avoided. It is an advantage
25 of embodiments of the present disclosure that the electrode layer is deposited at low temperatures, such that in embodiments wherein an amorphous (glassy) solid electrolyte layer is used and deposited before providing the electrode layer, the low deposition temperature of the electrode layer in accordance with embodiments of the present disclosure allows to preserve a high rate performance.

[0076] The substrate 10 may for example comprise a semiconductor material such a group IV
30 semiconductor material, e.g. silicon, a metal (e.g metal foil), a carbon nanosheet, a plastic foil or a ceramic material such as a silicate. In the example shown in FIG 1, the substrate 10 is a planar substrate. However, the substrate 10 may also be a non-planar substrate, e.g. comprising a plurality of 3D features or 3D microstructures, such as for example a plurality of micro-pillars, a plurality of nanowires or a substrate comprising 3D (nano)meshes, nanotubes and/or other porous structures, such as for example porous anodized alumina. The 3D
35 features may be present on the substrate in a regular pattern, such as for example a regular array pattern, or they may be randomly distributed over the substrate. For example, the substrate 10 may comprise an array of high aspect-ratio pillars, such as for example silicon pillars, on which the first collector layer 11 may be coated. The pillars may for example have a diameter in the range between 0.5 micrometer and 10 micrometer, a spacing of 1 micrometer to 20 micrometer and a height in the range between 10 micrometer and 200 micrometer, the present
40 disclosure not being limited thereto. It is an advantage of using a substrate comprising a plurality of 3D microstructures that it results in an increased battery capacity.

[0077] The first collector layer 11 may for example be a positive collector layer. The positive collector layer 12 is an electrically conductive layer, such as a metal layer (e.g. comprising Pt, Al, Cu, Ti, W or Au), a conductive polymer layer (e.g. polyaniline), a conductive ceramic layer (e.g. TiN) or a conductive oxide (e.g. RuO₂) or carbon layer, the present disclosure not being limited thereto. In embodiments of the present disclosure wherein the substrate 10 is an electrically conductive substrate, the substrate may also function as a first collector layer and there may be no need for providing a dedicated first collector layer 11.

[0078] The first electrode layer 12 may for example be a positive electrode layer or a cathode layer. For Li-ion batteries it may for example comprise LiCoO₂, MnO₂, LiMn₂O₄, LiNiO₂, Li_x(Mn_yNi_{1-y})_{2-x}O₂, LiNi_{1-x}Co_xO₂, LiNi_xCo_yAl_zO₂, Li(Ni_{1/3}Mn_{1/3}Co_{1/3})O₂, LiFePO₄, Li₂FePO₄F, V₂O₅, V₂O₅-TeO₂, WO₃-V₂O₅, TiS_xO_y, MO_x, MS_x or Li-V₂O₅, the present disclosure not being limited thereto. For other ion insertion type batteries, the first electrode layer 12 may for example comprise similar materials as listed above for Li-ion batteries, but with the Li being substituted by the other ion. For example, for Na-ion batteries the first electrode layer 12 may e.g. comprise NaMn₂O₄; for Mg-ion batteries the first electrode layer may e.g. comprise MgMn₂O₄; and for Al-ion batteries the first electrode layer may e.g. comprise Al_xV₂O₃, the present disclosure not being limited thereto.

[0079] The electrolyte layer 13 may for example comprise a separator (e.g. a microporous separator) soaked in a liquid electrolyte, a gel-polymer electrolyte or a solid-state electrolyte. For embodiments with a liquid electrolyte, the separator can for example comprise a polyolefin material such as a polyethylene or a polypropylene. The liquid electrolyte may comprise a solvent such as for example an organic solvent (e.g. propylene carbonate, dimethyl carbonate) or water. For Li-ion batteries the mobile ions (Li ions) may for example be provided in the liquid electrolyte by dissolving for example lithium hexafluorophosphate or lithium perchlorate in the solvent. For other ion insertion batteries, the mobile ions may be provided by using salts soluble towards the specific solvent used. For example, for Mg-ion batteries Mg(ClO₄)₂ may be dissolved in propylene carbonate to form the liquid electrolyte. Polymer-gel electrolytes may comprise a polymer host such as for example poly(ethyleneoxide) or poly(propyleneoxide) with a plasticizer and a salt. Solid electrolytes are solid ion conductors and may in case of a Li-ion battery for example comprise an organic material such as e.g. poly(ethyleneoxide)/LiCF₃SO₃, or an inorganic material such as a Lithium Super Ionic Conductor material (LISICON material, such as e.g. Li₁₄ZnGe₄O₁₆), a thio-LISICON material (such as e.g. Li₁₀GeP₂S₁₂), a Sodium Super Ionic Conductor material (NASICON material, such as e.g. Li_{1.3}Al_{0.3}Ti_{1.7}(PO₄)₃), a perovskite material (such as e.g. La_{0.5}Li_{0.5}TiO₃), a garnet material (such as e.g. Li₇La₃Zr₂O₁₂) or an amorphous material (such as e.g. LiPON, Li_{2.88}PO_{3.73}N_{0.14}), the present disclosure not being limited thereto.

[0080] The second electrode layer 14 may for example be a negative electrode layer or anode layer. As further described, in embodiments of the present disclosure this negative electrode layer or anode layer is a titanium oxide layer comprising chlorine, e.g. an amorphous titanium oxide layer comprising chlorine.

[0081] The second collector layer 15 may for example be a negative collector layer. The negative collector layer 15 is an electrically conductive layer, such as a metal layer (e.g. Cu, Ni, Al), an organic conductor layer (e.g. polypyrrole), a conductive ceramic layer (e.g. TiN, ITO) or a (nano)carbon (e.g. amorphous carbon, carbon nanosheet), the present disclosure not being limited thereto.

[0082] The present disclosure is related to ion insertion battery cells and ion insertion batteries, such as for example thin-film Li-ion batteries and battery cells (the present disclosure not being limited thereto), comprising a negative electrode layer that offers a good rate performance, such as a charging rate higher than 1C, and a capacity of at least 70% of the theoretical maximum capacity, even without nanostructuring or carbon composite

formation. In embodiments of the present disclosure the electrode material of the negative electrode layer 14 comprises, preferably consists of a titanium oxide comprising chlorine being either amorphous or a mixture of an amorphous titanium oxide comprising chlorine and a crystalline titanium oxide comprising chlorine. Preferably, the electrode material of the negative electrode layer 14 comprises, preferably consists of an amorphous titanium oxide. The ratio chlorine to titanium in the negative electrode layer 14 is preferably from 0.01 to 0.1, more preferably from 0.06 to 0.09, when measured by Rutherford Backscatter Spectroscopy. The titanium oxide comprising chlorine may have for general formula TiO_xCl_y , with $1 \leq x < 2.0$ and $0.01 \leq y \leq 0.1$. The titanium oxide comprising chlorine may have for general formula TiO_xCl_y , with x being about 2 and $0.01 \leq y \leq 0.1$. Without being bound by theory, the titanium oxide comprising chlorine may have for general formula $\text{TiO}_{2-y}\text{Cl}_y$ wherein y is from 0.01 to 0.1, preferably from 0.06 to 0.09. The capacity measured in examples according to the present invention is larger than the theoretical capacity calculated if the film would be able to accept 1 Li^+ per Ti by using the Ti(IV)-Ti(III) redox couple. This strongly suggests that more than one Li^+ is inserted per TiO_2 unit formula by using the Ti(III) and Ti(II) redox state. The enhanced electronic conductivity observed in embodiments of the present invention also suggests the permanent presence of Ti(III) states after substitution of O^{2-} by Cl^- in TiO_2 . This strongly suggests a general formula for the titanium oxide comprising chlorine as follow: $(\text{TiO}_2)_{1-y}(\text{TiOCl})_y$, which can be simplified as follow: $\text{TiO}_{2-y}\text{Cl}_y$. The thickness of the electrode layer may for example be in the range between 5 nm and 2 micrometer, for example between 5 nm and 1 micrometer, such as for example between 100 nm and 1 micrometer, the present disclosure not being limited thereto. When using a negative electrode layer according to embodiments of the present disclosure in a 3D battery structure, the thickness of the negative electrode layer may depend on, e.g. be limited by, the specific geometry of the 3D structure.

[0083] The present disclosure also provides methods for forming such negative electrode layers 14. An electrode layer according to embodiments of the present disclosure may be provided by means of an Atomic Layer Deposition process, wherein the deposition temperature is lower than 150°C , such as for example between 50°C and 130°C , and wherein TiCl_4 and H_2O are used as precursors.

[0084] Experiments were performed wherein 100 nm thick amorphous layers comprising a titanium oxide comprising chlorine with varying amounts of Cl were deposited. These layers showed near theoretical Li^+ -ion insertion capability at a rate of 0.2C (corresponding to a complete charging in 5 hours) and a very good retention of the capacity upon increased charging speed. This gives rise to an excellent Li^+ rate performance while being stable over many cycles.

[0085] In the experiments, amorphous layers comprising a titanium oxide comprising chlorine were deposited by means of Atomic Layer Deposition (ALD), using TiCl_4 and H_2O as precursors, at a deposition temperature lower than 150°C . The pre-cursors were dosed at a flow rate of 50 sccm for TiCl_4 and 500 sccm for H_2O . 100 nm thick thin-film electrode layers comprising a titanium oxide comprising chlorine were fabricated which showed superior performance in terms of capacity and rate performance. By lowering the deposition temperature, more chlorine can be incorporated, which in turn enhances the capacity and rate performance. Without being bound by theory, this mechanism may arise from an increase in the electronic conductivity and/or improved Li^+ diffusion within the electrode layer.

[0086] In the experiments, amorphous thin-film electrode layers comprising a titanium oxide comprising chlorine were deposited by spatial atomic layer deposition (s-ALD) using TiCl_4 and H_2O vapour as precursors. It is an advantage of spatial atomic layer deposition that it allows for faster deposition rates, such as for example

10 times faster deposition for a 100 nm thick layer, as compared to temporal atomic layer deposition. Such faster deposition rates potentially lower the fabrication cost. However, the present disclosure is not limited thereto. In embodiments of the present disclosure also temporal atomic layer deposition may be used for forming the amorphous thin-film electrode layers comprising a titanium oxide comprising chlorine, as well as other methods.

5 [0087] In an alternative approach for forming electrode layers according to embodiments of the present disclosure, for example a sol-gel based synthesis method could be used, based on a known route for the fabrication of TiO_2 but modified to include a Cl containing compound (such as HCl). For example, using a sol-gel based synthesis, an organometallic precursor of titanium such as titanium(IV) isopropoxide or titanium(IV) butoxide may be mixed with an amount of hydrochloric acid (HCl) in solution. Such an approach would enable
10 the fabrication of (nano)particles comprising a titanium oxide comprising chlorine, for example for use as an active material in a (nano)particle based electrode layer.

[0088] It is an advantage of using ALD for the deposition of a thin-film electrode layers in accordance with embodiments of the present disclosure that it allows for the deposition of smooth films with well controlled properties, such as for example a well-controlled layer thickness and a well-controlled Cl content. This may for
15 example be achieved by varying the deposition temperature, the TiCl_4 and/or H_2O dosage and the exposure time. For example, the Cl content can be controlled / varied by varying the deposition temperature or by varying the exposure time to the TiCl_4 precursor. In experiments performed with a spatial ALD system, it was observed that more Cl was incorporated in the electrode layer when lowering the deposition temperature. It is an advantage of ALD deposition that the deposition temperature may be lower than 150°C , e.g. between 50°C and 150°C . Such
20 low deposition temperature allows preventing crystallization of the negative electrode layer. This may in addition result in smooth layers with a low surface roughness, such as ≤ 5 nm RMS roughness, e.g. ≤ 1 nm RMS roughness. Due to the self-limiting growth of ALD, it is a further advantage of using ALD that it allows for a conformal deposition, which is required for the development of 3D thin-film batteries. If desired, a post-deposition anneal may be performed to achieve a crystalline thin layer comprising a titanium oxide comprising
25 chlorine, e.g. a single crystalline or a polycrystalline thin layer, or a layer comprising a mixture of a crystalline and amorphous states.

[0089] The spatial ALD concept is based on the spatial separation of the half-reactions instead of a temporal separation. A spatial ALD reactor has separate zones exposing the different precursors one by one to a substrate that moves underneath the reactor. Between and around the reaction zones, shields of inert gas separate the
30 precursor flows. In the experiments described here, the layers comprising a titanium oxide comprising chlorine were deposited in a reactor wherein the separate reaction zone inlets are incorporated in a round reactor head mounted on top of a rotating table holding the substrate. The precursor inlets are incorporated in the round reactor head and surrounded by exhaust zones.

[0090] Amorphous thin-films comprising a titanium oxide comprising chlorine in accordance with
35 embodiments of the present disclosure were deposited on a TiN/Si substrate. The substrates were prepared by sputter deposition of a 70 nm thick TiN layer on 200 mm Si wafers. The wafers were diced in 2cm x 2 cm pieces, on which further ALD deposition and characterization was performed. For the spatial atomic layer deposition (s-ALD), four 2cm x 2cm samples were mounted on a holder and loaded into the s-ALD reactor. Precursors for the deposition were TiCl_4 and H_2O , which were dosed at 50 sccm and at 500 sccm, respectively. Depositions at 20,
40 30 and 40 rpm substrate rotation speed were performed, which directly influenced the exposure time of the precursors to the substrate. The amount of rotation cycles was adjusted so that the resulting film thickness was

100 nm. Depending on the temperature, this was between 1155 to 1538 cycles. The temperature of the substrate was controlled during deposition and fixed at different temperatures between 50°C and 130°C.

[0091] The stoichiometry of the films comprising a titanium oxide comprising chlorine was determined using X-ray Photoelectron Spectroscopy (XPS) and Rutherford Backscatter Spectroscopy (RBS). FIG 2 shows XPS measurement results illustrating the chlorine to titanium ratio (filled circles) and the oxygen to titanium ratio (filled squares) for the thin ALD films comprising a titanium oxide comprising chlorine, as a function of the ALD deposition temperature. FIG 3 shows RBS measurement results showing the Cl/Ti ratio for the thin ALD films of titanium oxide comprising chlorine, as a function of the ALD deposition temperature.

[0092] From the XPS measurements (FIG 2) it can be concluded that the Cl/Ti ratio is between 0.01 and 0.07 for depositions performed at a deposition temperature between 50°C and 130°C, and that the Cl/Ti ratio decreases with increasing deposition temperature. The O/Ti ratio is seen to be about 2.3 for the different deposition temperatures in this range, meaning that it is substantially independent on the deposition temperature. The O/Ti ratio obtained from the XPS measurements is higher than the expected ratio of about 2, because in these measurements no correction was done for taking into account the presence of OH-surface species.

[0093] From the RBS measurements (FIG 3), a similar trend is measured for the Cl/Ti ratio, showing that a lower deposition temperature leads to a higher Cl/Ti ratio in the ALD deposited films of titanium oxide comprising chlorine. Using RBS, a Cl/Ti ratio in the range between 0.064 and 0.088 was measured for films of titanium oxide comprising chlorine deposited between 100°C and 130°C. Without being bound by theory, the discrepancy between the XPS measurement results shown in FIG 2 and the RBS measurement results shown in FIG 3 may be related to XPS being a surface sensitive technique whereas RBS is a “bulk” technique. Therefore, the XPS results show the composition of the upper few nanometers of the layer of titanium oxide comprising chlorine whereas the RBS results show the bulk composition, reflecting the total Cl content. Also, for the RBS measurements there may have been some interference with the underlying TiN substrate which might lead to over- or underestimation of the Cl content. Furthermore, a small influence of the rotation speed (i.e. exposure time of the precursors) of the rotating table holding the substrate on the Cl/Ti ratio was observed, with a lower Cl/Ti ratio for lower rotation speeds. This effect is however less significant than the effect of the deposition temperature. Nevertheless, this means that, apart from or in addition to the deposition temperature, also the rotation speed may be used as a control mechanism for modifying the Cl content of a layer of titanium oxide comprising chlorine in embodiments of the present disclosure.

[0094] From the RBS measurement results, also the absolute Ti content in the layers was derived. Using a layer thickness of 100 nm, the density of the material for all values of y was calculated to be about 2.8 g/cm³. This is significantly lower than for example the density of anatase TiO₂ (3.8 g/cm³).

[0095] For the electrochemical characterization of the thin-films of titanium oxide comprising chlorine, a custom-made three-electrode Teflon cell was used which can be clamped onto the substrate and filled with an electrolyte. The cell contains two compartments, one compartment comprising a Li metal foil as a counter electrode and the other compartment comprising a Li metal foil as a reference electrode. The compartment with the Li reference electrode was connected to the main compartment through a lugging capillary close to the surface of the working electrode. All experiments were performed at room temperature (21°C) using 1M LiClO₄ in propylene carbonate (PC) as an electrolyte. Measurements were done in an Ar filled glove box with 1ppm O₂ and 0 ppm H₂O. Contact was made to the substrate by scratching the back of the sample and applying a GaIn

paste and contacting with Cu foil. The electrochemical cell was controlled through a PGSTAT101 Autolab (Metrohm) using the Nova 1.10 software.

5 [0096] Cyclic voltammetry was performed for 5 cycles between 0.1V and 3.2V at 10 mVs⁻¹. Subsequently, galvanostatic charge/discharge experiments were carried out with current densities ranging from 2.6 to 530 $\mu\text{A}/\text{cm}^2$ with cut-off voltages of 3.0 and 0.1V to characterize the Li⁺-ion storage capacity. All voltages are given versus Li⁺/Li.

[0097] In the ideal case, the film of titanium oxide comprising chlorine would be able to accept 1 Li⁺-ion per Ti (by using the Ti(IV)-Ti(III) redox couple), which would lead to a maximum theoretical capacity of ~1280 mAh/cm³ assuming a density corresponding to the anatase TiO₂ density.

10 [0098] FIG 4 shows the potential-capacity curves as determined from charge / discharge measurements at a rate of 0.4C (5.3 $\mu\text{A}/\text{cm}^3$) for 100 nm thick thin films of titanium oxide comprising chlorine in accordance with embodiments of the present disclosure for different Cl contents (curve a: y = 0.06; curve b: y = 0.07 and curve c: y = 0.09). The Cl content (y-value) was determined from RBS measurements. In addition, the potential-capacity curve measured for a 35 nm thick amorphous TiO_x layer (without Cl incorporation) is shown as a reference (curve
15 d). For all layers a sloped potential profile is obtained, which is typical for amorphous TiO₂. The largest capacity is reached with the highest Cl content (in this case of titanium oxide comprising chlorine with a ratio Cl/Ti as measured by RBS of 0.09). The 100 nm film of titanium oxide comprising chlorine with a ratio Cl/Ti as measured by RBS of 0.06 has the lowest capacity.

[0099] In an ideal system, the total capacity of a thin-film electrode (capacity expressed in mAh/cm²) depends linearly on the film thickness (layer thickness). The thicker the electrode layer, the more capacity per area is available as there is more active material per area. Therefore, it would be expected that when increasing the amorphous TiO₂ film thickness from 35 nm to 100 nm, there would be a linear increase in capacity (or otherwise stated, it would be expected that the volumetric capacity remains constant). When comparing the capacity (in mAh/cm²) between the prior art 35 nm amorphous TiO₂ layer and a 100 nm thick titanium oxide
25 comprising chlorine with a ratio Cl/Ti as measured by RBS of 0.06 in accordance with an embodiment of the present disclosure as shown in FIG 4, it is observed that there is a decrease in areal capacity, contrary to what may be expected. This may be explained by a secondary effect of increased film thickness, namely an increase in electronic and ionic resistance, as the distance of charge transport within the layer increases. These increased resistances may effectively limit the available capacity at a certain charging rate. A way to circumvent this
30 problem would be to limit the charging rate, which would in turn mean that it would take much longer to charge/discharge the electrode. Based on the results shown in FIG 4, in the case of the 100 nm electrode layer of titanium oxide comprising chlorine with a ratio Cl/Ti as measured by RBS of 0.06 from the experiments, the resistive losses result in an areal capacity that is less than for a prior art 35 nm amorphous TiO₂ electrode layer at equal charging rates. This shows that, in this specific case, simply increasing the film thickness limits the rate
35 performance of the films, which in turn decreases the available capacity. However, the experimental results also show that according to this example, when an electrode layer according to embodiments of the present disclosure has a higher Cl content (e.g. an electrode layer of titanium oxide comprising chlorine with a ratio Cl/Ti as measured by RBS of 0.09), a higher capacity of about 12 $\mu\text{Ah}/\text{cm}^2$ (or about 1200 mAh/cm³) is achieved for a 100 nm thick electrode layer. It may be expected that due to the excellent rate performance of the layer of titanium
40 oxide comprising chlorine with a ratio Cl/Ti as measured by RBS of 0.09, increasing the thickness of such a layer

above 100 nm may further increase the capacity (above 12 $\mu\text{Ah}/\text{cm}^2$), while maintaining the charging capabilities above 1C.

[0100] FIG 5 shows the volumetric capacity as a function of C-rate as determined from charge / discharge measurements for 100 nm thick thin films of titanium oxide comprising chlorine in accordance with embodiments of the present disclosure for different Cl contents (curve a: $y = 0.06$; curve b: $y = 0.07$ and curve c: $y = 0.09$). The rate performance was probed by varying the applied current density during charge and discharge (where 1C = $\sim 12.8 \mu\text{A}/\text{cm}^2$ or $1280 \text{ mA}/\text{cm}^2$). The results of FIG 5 show at the lowest measured C-rate (0.5C), a volumetric capacity of 1189, 791 and $204 \text{ mAh}/\text{cm}^3$ for titanium oxide comprising chlorine with a ratio Cl/Ti as measured by RBS of 0.09, 0.07 and 0.06, respectively. The theoretical capacity for a 100 nm thick TiO_2 layer is $1280 \text{ mAh}/\text{cm}^3$ (assuming the anatase density), which shows that the layers of titanium oxide comprising chlorine with a ratio Cl/Ti as measured by RBS of 0.09 according to embodiments of the present disclosure may achieve about 94% of this theoretical volumetric capacity at 0.5C. At 20C for example, the film of titanium oxide comprising chlorine with a ratio Cl/Ti as measured by RBS of 0.09 retains 50% of the 0.5C capacity, which is extremely high for active materials which are in this thickness regime (i.e. 100nm). For the calculation of the theoretical capacity the density for anatase titanium oxide ($3.82 \text{ g}/\text{cm}^3$) was used, which could lead to an overestimation of the theoretical capacity, considering that it was shown by RBS that the amorphous layers according to embodiments of the present disclosure are likely less dense. Using the density as measured by RBS in the calculations ($2.8 \text{ g}/\text{cm}^3$), the theoretical capacity would be $940 \text{ mAh}/\text{cm}^3$. This is lower than the value measured for titanium oxide comprising chlorine with a ratio Cl/Ti as measured by RBS of 0.09 ($1189 \text{ mAh}/\text{cm}^3$), suggesting either an insertion of more than 1 Li^+ per TiO_2 unit formula (by using the Ti(III) and Ti(II) redox state), and/or giving an indication that the density calculated from RBS is underestimated.

[0101] FIG 6 shows the volumetric delithiation capacity measured at a current density of $5.3 \mu\text{A}/\text{cm}^2$ (0.4C) as a function of the Cl content y for 100 nm thick layers of titanium oxide comprising chlorine formed in accordance with embodiments of the present disclosure. The highest Cl content for which these electrochemical properties were measured was a Cl content $y = 0.09$. This layer was deposited by means of spatial ALD at a deposition temperature of 100°C . Layers with even higher Cl contents may be deposited by further lowering the ALD deposition temperature.

[0102] Further experiments were performed wherein electrode layers of titanium oxide comprising chlorine in accordance with embodiments of the present disclosure were deposited on a substrate comprising 3D structures, more in particular on a substrate comprising silicon micro-pillars. The silicon micro-pillars were fabricated on 300 mm Si wafers by photolithography and deep reactive ion etching. The silicon micro-pillars were provided in a regular pattern (arranged in a square lattice) over an area of $1 \text{ cm} \times 1 \text{ cm}$. The diameter of the $50 \mu\text{m}$ high micro-pillars was about $2 \mu\text{m}$, with an inter-pillar spacing of $2 \mu\text{m}$. A 21 nm thick TiN current collector layer was deposited on the micro-pillars by means of temporal ALD. Next electrode layers of titanium oxide comprising chlorine were deposited on the substrate comprising the silicon micro-pillars with TiN current collector, by means of spatial ALD, at different deposition temperatures (100°C , 115°C and 130°C). TiCl_4 and H_2O were used as precursors at a flow rate of 50 sccm for TiCl_4 and 500 sccm for H_2O .

[0103] In order to characterize the conformality of the layers of titanium oxide comprising chlorine, the layer thickness on the walls at the edge of the micro-pillar array was measured as a function of depth (i.e. as a function of the distance from the top of the micro-pillars). For practical reasons, these measurements were done at an edge of the micro-pillar array, but the thickness of the layers of titanium oxide comprising chlorine with a

ratio Cl/Ti as measured by RBS of 0.06 at the edge of the array is assumed to be representative for the thickness on the micro-pillars. The result of those thickness measurements is shown in FIG 7. When comparing the top thickness (distance from top 0 μm) with the bottom thickness (distance from top 50 μm), it can be seen that there is at most a 20% drop in the thickness along the depth of the pillars. The process can be further optimized by increasing the exposure to the precursors, e.g. by decreasing the rotation speed of deposition.

[0104] The thin-film electrode layers of titanium oxide comprising chlorine deposited at 100°C on the 3D micro-pillar array structure were characterized electrochemically in terms of rate performance, and the results were compared to the rate performance of thin-film electrode layers of titanium oxide comprising chlorine of the same composition deposited on a planar substrate. FIG 8 shows the measured rate performance of a 100 nm thick layer of titanium oxide comprising chlorine with a ratio Cl/Ti as measured by RBS of 0.09 deposited on a planar TiN-coated silicon substrate (filled squares) and the measured rate performance of a 100 nm thick titanium oxide comprising chlorine with a ratio Cl/Ti as measured by RBS of 0.09 deposited on the 3D silicon micro-pillar array as described above (filled circles). At the lowest applied C-rate (0.2C), a capacity of 11.9 $\mu\text{Ah}/\text{cm}^2$ was measured for the electrode layer deposited on the planar substrate, and a capacity of 242 $\mu\text{Ah}/\text{cm}^2$ (per footprint area) was measured for the electrode layer deposited on the 3D substrate. This shows that the capacity for the 3D electrode is about a factor of 20.3 times higher than the capacity of the planar electrode, which is in line with the expected area increase of the micro-pillar array (i.e. about 20.6 times increase). The measured results shown in FIG 8 further illustrate that this capacity increase is achieved without any significant loss in rate performance. For example, at a rate of 20C, a capacity of 4.56 $\mu\text{Ah}/\text{cm}^2$ was measured for the electrode layer deposited on the planar substrate, and a capacity of 89 $\mu\text{Ah}/\text{cm}^2$ (per footprint area) was measured for the electrode layer deposited on the 3D substrate, which corresponds to a 19.5 times increase of the capacity. This shows that the capacity can effectively be scaled using 3D structures, while maintaining the fast charging characteristics.

[0105] Further, the stability of the electrode layers of titanium oxide comprising chlorine with a ratio Cl/Ti as measured by RBS of 0.09 deposited on the 3D silicon substrate comprising micro-pillars was tested. FIG 9 shows the lithiation and delithiation capacity measured at a rate of 2C (0.53 mA/cm^2 footprint). The capacity at the first cycle is 177 $\mu\text{Ah}/\text{cm}^2$, of which 95.4% is retained at the 50th cycle. Therefore, it may be concluded that the 3D electrode layer of titanium oxide comprising chlorine with a ratio Cl/Ti as measured by RBS of 0.09 for lithium-ion insertion/extraction is stable and can reversibly insert/extract lithium-ions for many cycles with minimal loss in capacity.

[0106] Further examples

[0107] Methods for the preparation of planar and micropillar substrates

[0108] Planar substrates: A 200 mm n-type phosphorous doped crystalline Si wafer was coated with 60 nm TiN by physical vapor deposition, diced in 1 x 1 cm^2 pieces and subsequently used as-is for Spatial Atomic Layer Deposition (s-ALD) amorphous TiO_2 (am- TiO_2) deposition and subsequent electrochemical characterization. TiN was chosen as it functions as current collector and diffusion barrier for lithium into the Si. Growth per cycle determination of the s-ALD am- TiO_2 process were performed on am- TiO_2 deposited 152 mm Si wafers.

[0109] Silicon micropillar substrate: A 300 mm n-type phosphorous doped Si wafer was used for the Si micropillar fabrication. Standard photolithographic patterning, combined with deep reactive ion etching were employed to fabricate the pillar structures. Si micropillar arrays were defined on the 300 mm wafer in 1 x 1 cm^2 squares, with 1 cm spacing in-between the arrays. Pillars were ordered in a square lattice, with a diameter and inter-pillar spacing of 2 μm , and a (nominal) height of 50 μm (see supplementary information for a schematic).

A 23 nm TiN current collector was deposited on the pillars by conventional ALD using a plasma based process at 370 °C. Planar and micropillar substrates used in SEM and electrochemical characterization were diced in 2 x 2 cm² squares (with micropillar array in the center) on which s-ALD deposition was performed.

[0110] Structural characterization

5 **[0111]** As it will become clear in from the rest of this disclosure, experimental results points to aTiO_{2-y}Cl_y for the general formula of the titanium oxide comprising chlorine. This is therefore the notation that will be used in the rest of this text for the sake of compacity. The thickness and surface morphology of TiO_{2-y}Cl_y films deposited on planar TiN/Si and micropillar substrates were examined with a NOVA 200 (FEI) scanning electron microscope (SEM). The chemical state and content of chlorine in the TiO_{2-y}Cl_y layers were determined using X-
10 ray photoelectron spectroscopy (XPS) and Rutherford Backscattering Spectroscopy (RBS). XPS was carried out with the Quantera tool from ULVAC-PHI (Q1). Prior to XPS measurements, surface contaminations of the samples were removed by a 2 minutes sputter clean at 1 keV with Ar⁺ ions. For RBS measurements, a He⁺ beam is accelerated to an energy of 1.52 MeV and scattered off the film. The backscattered ions are detected by a time-of-flight energy telescope, which give information on the elemental composition.

15 **[0112]** Electrochemical characterization

[0113] A custom-made three-electrode polytetrafluoroethylene (PTFE) cell was used which is clamped onto the substrate using a Kalrez® O-ring (exposed surface area of 1.1 and 1.79 cm² for planar and 3D substrates, respectively) and filled with a liquid electrolyte (10 - 15 mL). The cell contains two compartments, one compartment comprising a Li metal foil as a counter and the other comprising a Li metal foil as a reference
20 electrode. The compartment with the Li reference electrode was connected to the main compartment through a lugging capillary close to the surface of the working electrode (at ~4 mm). All experiments were performed at room temperature (21 °C) using a LiClO₄ in propylene carbonate electrolyte solution. For ease of preparation, an ampoule containing LiClO₄ (100 g, battery grade, dry, 99.99%, Sigma Aldrich) was dissolved in propylene carbonate (100 mL, 99.7%, Sigma Aldrich), which leads to a 0.94 M solution. Measurements were done in an Ar
25 filled glove box with O₂ and H₂O kept below 1 ppm. Electrical contact was made to the samples by scratching the back of the sample and applying a gallium indium eutectic (Alfa Aesar) and contacting with Cu foil. The electrochemical cell was controlled through a PGSTAT101 Autolab (Metrohm) potentiostat/galvanostat, using the Nova 1.10 software. Five cyclic voltammogram (CV) cycles were recorded at 10 mV s⁻¹ in the range of 0.1 V to 3.2 V, after which galvanostatic lithiation/delithiation experiments were carried out with cut-off voltages of
30 3.0 and 0.1 V. Between CVs and lithiation/delithiation experiments, the electrode was relaxed at 3.0 V until a 1/50 C cut-off current was reached. Specifically, for the planar samples, a current of 5, 10, 25, 50, 100, 250, 500, 2.5 and 5 μA was consecutively applied. For the 3D samples, 0.1, 0.2, 0.5, 1, 2 and 5, 0.05 and 0.1 mA were applied in sequence. Long term cycling tests were done using a 3D electrode with TiO_{2-y}Cl_y deposited at 100 °C/
35 70 ms. Before long term cycling, five CV cycles were recorded at 10 mV s⁻¹. Subsequently 1000 lithiation and delithiation cycles at a rate of 10 C, and 5 cycles at 1 C were applied. All voltages are given versus Li⁺/Li.

[0114] Results

[0115] Spatial ALD of (chlorine doped) titanium oxide films

[0116] A rotary type reactor was used which allows up to 152 mm round substrates to be mounted. Precursor inlets are surrounded by exhaust zones and are incorporated in a 150 mm diameter round reactor head
40 situated above the sample. The inlets are surrounded by gas bearing planes, which separate the different reaction zones and prevent precursor intermixing. Gas bearing is formed by flowing pressurized N₂ through holes located

on the gas bearing surface. The sample table can be rotated at different rotation frequencies. The entire construction is mounted in a convection oven which controls the deposition temperature. Depositions were done simultaneously on four $2 \times 2 \text{ cm}^2$ samples which were mounted on a holder and loaded into the s-ALD reactor. For each deposition run, two planar and two 3D substrates were loaded. The deposition precursors were TiCl_4 and H_2O , each dosed at 50 sccm and 500 sccm, respectively. The temperature of the precursor bottles was controlled outside the reactor and kept at room temperature for TiCl_4 and at 50°C for H_2O . Depositions with 20, 30 and 40 rpm substrate rotation frequencies were performed, which correspond to 140, 90 and 70 ms of gas exposure time at the center of the sample, respectively. Substrate temperatures were fixed at 100, 115 or 130°C , which is low enough to form amorphous TiO_2 films. The growth per cycle was determined by spectroscopic ellipsometry with TiO_2 layers deposited on full 152 mm Si wafers (data not shown), which, depending on the distance from the center of the wafer, allowed probing several exposure times in the same deposition run. For 100, 115 and 130°C a growth per cycle of 0.085, 0.080 and 0.075 nm/cycle was determined. Using these values, 1155, 1225 and 1538 rotation cycles were adopted to achieve a 100 nm film, respectively. As a chlorine free reference, am- TiO_2 samples were deposited by s-ALD at 100°C and 10 rpm rotation frequency using titanium tetraisopropoxide (TTIP) and H_2O as precursor. The longer exposure time for TTIP (vs. TiCl_4) is needed to ensure self-limiting growth.

[0117] The thickness and morphology of the deposited films on planar TiN/Si substrates were determined by scanning electron microscopy (SEM) which showed, smooth, closed and crack-free films for the layers deposited at 100 and 115°C . For the films deposited 130°C , however, some particulate features were visible from SEM (not shown). Because of non-uniformity of the 130°C $\text{TiO}_{2-y}\text{Cl}_y$ film and associated difficulties in determining the exact film density (see below), we did not evaluate these further for electrochemical performance.

[0118] Chemical analysis of chlorine-doped Titanium oxide films

[0119] The stoichiometry of the chlorine doped TiO_2 films was measured using Rutherford Backscatter Spectroscopy (RBS). Table 1 gives the results of the Ti content, Cl:Ti atomic ratio and film density for the different deposition conditions. An equal Ti content is measured for depositions performed at 100 and 115°C (both for TiCl_4 and TTIP), whereas the Ti content is higher for 130°C . Based on the $\text{TiO}_{2-y}\text{Cl}_y$ stoichiometry, a density of 2.8 g cm^{-3} is calculated for layers deposited at 100°C and 115°C , irrespective of exposure time. Note that this density is considerably lower than for example bulk anatase TiO_2 ($\sim 3.8 \text{ g cm}^{-3}$). For deposition at 130°C , a density of 3.3 g cm^{-3} is calculated, which, without being bound by theory, is likely related to overestimation of the Ti content in the closed film due to the agglomerates present on top of the surface. Based on the Ti content and by assuming the reduction of Ti(IV) to Ti(III) , a theoretical volumetric capacity of 935 mAh cm^{-3} is calculated both for TiCl_4 and TTIP-based TiO_2 deposited at 100°C and 115°C .

[0120] Next, the Cl content was analyzed for the different layers deposited with the TiCl_4 and TTIP precursor. The highest Cl content ($\text{TiO}_{1.912}\text{Cl}_{0.088}$) was achieved for the lowest deposition temperature of 100°C . Deposition at 115°C and 130°C all lead to lower Cl contents compared to 100°C . For deposition at 115°C , the influence of gas precursor exposure time on Cl content was investigated, which shows that a shorter exposure time leads to more incorporated Cl. Hence, both deposition temperature and exposure time can be used to control the Cl content. For the TTIP-based amorphous TiO_2 layers deposited by s-ALD, no Cl was measured as there is no chloride in the precursor.

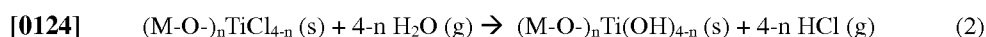
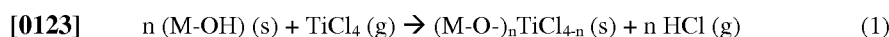
[0121] In Table 1, the Ti content, Cl:Ti atomic ratio, film density and theoretical volumetric capacity as measured by RBS for 100 nm amorphous TiO₂ films deposited by S-ALD at different deposition conditions (temperature / exposure time) and gas precursors are presented.

	Temperature / exposure time	Ti content (10 ²³ at cm ⁻³)	Cl:Ti atomic ratio	Density* (g cm ⁻³)	Theoretical vol. capacity (mAh cm ⁻³) ⁺
TiCl ₄ + H ₂ O	100 °C / 70 ms	21	0.088	2.84	935
	115 °C/ 70 ms	21	0.074	2.84	935
	115 °C/ 90 ms	21	0.060	2.83	935
	115 °C/ 140 ms	21	0.059	2.82	935
	130 °C/ 90 ms	25	0.064	3.31	1092
TTIP + H ₂ O	100 °C/ 220 ms	21	0	2.79	935

*Based on the TiO_{2-y}Cl_y stoichiometry

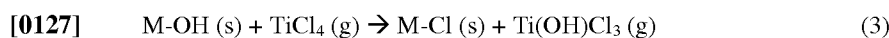
5 ⁺Calculated from the Ti content for the reduction of Ti(IV) to T(III).

[0122] Fig 10 shows the XPS spectrum in the energy range for Ti-Cl binding of TiO_{2-y}Cl_y films grown at 100 and 130 °C by s-ALD, with a peak around 199 eV, corresponding to Ti-Cl bonding energy. The shoulder apparent in the spectrum is due to the orbital splitting in 3p_{3/2} and 3p_{1/2}. For similar layer thicknesses, the amount of chlorine is higher at lower temperatures, in accordance with RBS measurements. This implies that more chlorine is bound to titanium at lower temperatures. Without being bound by theory, several mechanisms can explain the Ti-Cl bond existence in the thin films. Ideal growth of the film would follow the following reaction paths:

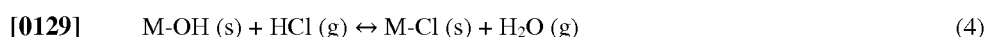


15 **[0125]** Without being bound by theory, a first possible explanation of the presence of persistent Cl could be an incomplete ligand exchange reaction of -Cl with -OH (Eq. 2). This can happen when the H₂O dose (i.e. combination of H₂O partial pressure and exposure time) is insufficient to lead to a completed reaction. On the other hand, the observed Cl/Ti ratio might be the result of a chemical equilibrium forming at the specific deposition temperature. In this case, increasing the H₂O dose would not lead to changes in the Cl/Ti ratio.

20 **[0126]** More complex mechanisms, like non-growth ligand exchange reactions, can also take place. For example, the following reaction can occur:



[0128] The species formed in this reaction are mobile species that can also migrate on the surface of the material. These species are typically only observed at deposition temperatures of 200 °C and higher. A possible variation could be the competition reaction of gaseous HCl, formed during either H₂O or TiCl₄ pulse, with surface hydroxyl groups formed:



[0130] resulting in the formation of inactive sites for TiCl₄ pulse and incorporation of chlorine in the film. A study by Leem et al. shows that addition of a HCl pulse after the TiCl₄ pulse to the ALD cycle decreases the thickness of the layer, thus decreasing the number of active sites.

[0131] From RBS it is apparent that at increased pulse and purging times (these are related in the current setup) the amount of chlorine incorporated decreases. This hints towards an incomplete ligand exchange reaction, but does not exclude the other possible causes.

[0132] Electrochemical Performance of Chlorine-Doped titanium oxide Films

5 [0133] Li^+ -ion insertion/extraction properties of the 100 nm amorphous $\text{TiO}_{2-y}\text{Cl}_y$ films deposited by s-ALD from a TiCl_4 and TTIP (am- TiO_2) precursor on planar TiN-Si substrates were determined by cyclic voltammetry and galvanostatic charge/discharge experiments, as shown in Fig 11. The fifth cyclic voltammogram (CV) performed at 10 mV s^{-1} and measured between 3.2 and 0.1 V for the different am- $\text{TiO}_{2-y}\text{Cl}_y$ and the am- TiO_2 layers is given in Fig. 11a. The current response is clearly dependent on the specific deposition condition
10 of the films and thus the chloride content. The largest overall current density is measured for the $\text{TiO}_{1.912}\text{Cl}_{0.088}$ film ($100^\circ\text{C} / 70 \text{ ms}$) (solid line). For this layer, well defined, broad reduction and oxidation peaks are observed around 1.3 and 1.6 V vs Li^+/Li , respectively, which are assigned to the Li^+ -ion insertion and extraction into the amorphous $\text{TiO}_{1.912}\text{Cl}_{0.088}$ structure. The shape of the CV curve is similar to previously reported nanosized am- TiO_2 and to the chlorine free TTIP am- TiO_2 reference (long dash line). For the TiCl_4 -based $\text{TiO}_{2-y}\text{Cl}_y$ films, a
15 lower Cl content leads to less defined reduction peaks with lower current densities. The dash dot line corresponds to a $\text{TiO}_{1.926}\text{Cl}_{0.074}$ film ($115^\circ\text{C}/70 \text{ ms}$). The dotted line corresponds to a $\text{TiO}_{1.940}\text{Cl}_{0.060}$ film ($115^\circ\text{C}/90 \text{ ms}$). The short dash line corresponds to a $\text{TiO}_{1.941}\text{Cl}_{0.059}$ film ($115^\circ\text{C}/140 \text{ ms}$).

[0134] Fig 11b shows the Galvanostatic charge/discharge experiments and resulting potential vs capacity profiles (constant current delithiation curves) obtained at a rate of 0.5 C ($+4.5 \mu\text{A cm}^{-2}$) for the different $\text{TiO}_{2-y}\text{Cl}_y$ films. The measured capacity strongly depends on the Cl⁻ content, and the highest capacity is reached for the
20 highest Cl content ($y = 0.088$, solid line). The dash dot line corresponds to a $\text{TiO}_{1.926}\text{Cl}_{0.074}$ film ($115^\circ\text{C}/70 \text{ ms}$). The dotted line corresponds to a $\text{TiO}_{1.940}\text{Cl}_{0.060}$ film ($115^\circ\text{C}/90 \text{ ms}$). The short dash line corresponds to a $\text{TiO}_{1.941}\text{Cl}_{0.059}$ film ($115^\circ\text{C}/140 \text{ ms}$). The long dash line corresponds to a chlorine free TTIP am- TiO_2 reference. The voltage-capacity profile is also similar to previous reports on nanosized am- TiO_2 , and for all samples tested,
25 most delithiation ($> 65\%$) occurs between 1 V and 2 V vs Li^+/Li . The average coulombic efficiency for all lithiation/delithiation tests across the different C-rates was around 93%. In general, we saw that the rate-performance is limited by the delithiation step, and therefore, the delithiation capacity is shown in what follows.

[0135] The rate-performance of $\text{TiO}_{2-y}\text{Cl}_y$ films was investigated by applying different C-rates (between 0.25 - 50 C) in the voltage range of 3.0 to 0.1. The (delithiation) capacity against the C-rate is shown in Fig. 11c.
30 At 0.25 C, capacities of 10.3, 6.8, 3.7 and $1.8 \mu\text{Ah cm}^{-2}$ are obtained for $y = 0.088$ (plain circles), 0.074 (diamonds), 0.060 (triangles) and 0.059 (squares), respectively. Furthermore, the $\text{TiO}_{1.912}\text{Cl}_{0.088}$ layer delivers 330% more capacity than the chlorine free am- TiO_2 reference ($2.4 \mu\text{Ah cm}^{-2}$, hollow circles). At higher C-rates, the accessible capacity for $\text{TiO}_{1.911}\text{Cl}_{0.088}$ is 83% and 26% of the maximum capacity, at a rate of 1 C and 50 C, respectively.

35 [0136] In Fig. 11d, the maximum delithiation capacities obtained at 0.25 C were plotted against the Cl:Ti atomic ratio obtained from RBS. The meaning of the square, triangle, diamond, full and hollow circles is as defined in Fig. 11c. As a reference, the capacity of the Cl-free film is given as well. A linear fit of the capacity vs Cl:Ti atomic ratio was performed ($R^2 = 0.95$) of the Cl-containing samples. All voltages are given vs Li^+/Li . As shown above, the more chlorine, the higher the Li^+ -ion storage capacity. Interestingly, a linear relationship is
40 found between the Cl:Ti atomic ratio and the maximum capacity which intercepts the capacity of Cl-free am-

TiO₂ around $y = 0.06$. Hence, for enhancement in maximum capacity, a composition of TiO_{2-y}Cl_y with $y > 0.06$ is advantageous.

[0137] For $y = 0.09$ an enhancement of 5 times the capacity of the Cl-free am-TiO₂ is obtained. At this point, no saturation is yet seen and further enhancement could be possible for even higher Cl-content. A decrease of deposition temperature below 100 °C could in principle increase the Cl-content. However, 100 °C is currently near the limit of the self-limited ALD process.

[0138] Normalizing the maximum delithiation capacity of the film with highest Cl content (TiO_{1.912}Cl_{0.088}) to its weight determined from the film thickness and RBS density, leads to a gravimetric capacity of 362 mAh g⁻¹ at 0.25 C. Interestingly, this value is higher than that expected for insertion of 1 Li per TiO₂ (= 336 mAh g⁻¹). This suggests that a fraction (~10%) of Ti(III) can be reversibly reduced to Ti(II). Thermodynamically, the reduction of Ti(III) to Ti(II) in crystalline TiO₂ is possible from a potential of 0.37 V vs Li⁺/Li. However, it is thought to be kinetically inaccessible and to our knowledge only observed once for the case of small titania nanoparticles (< 10 nm) coated with Li metal.

[0139] Without being bound by theory, the present results suggest that further reduction to Ti(II) in sub-micron thick am-TiO₂ films can be obtained by doping with chlorine.

[0140] In Fig 12, we compare the gravimetric storage capacity at 1 C (= 336 mAg⁻¹) of the best performing chlorine doped am-TiO₂ (TiO_{1.912}Cl_{0.088}, full star) of the present disclosure and the Cl-free am-TiO₂ electrode with nanoscaled TiO₂ electrodes reported in the prior art. The prior art gravimetric storage capacity at 1C present in Fig 12 are derived from the following references: M. J. Sussman et al., Chem. Eng. 2015, 3, 334; G. Lui et al., Nano Energy 2016, 24, 72; B. Wang et al., ChemNanoMat 2015, 1, 96; K. Saravanan et al., Energy Environ. Sci. 2010, 3, 939; J. Ye et al., ACS Nano 2015, 9, 2194 ; Y. Shen et al., Nanoparticle Res. 2013, 15, 1913 ; Z. Jin et al., Nanotechnology 2014, 25, 395401 ; J. Cheng et al., J. Mater. Chem. A 2014, 2, 2701; X. Xin et al., ACS Nano 2012, 6, 11035 ; J. Liu et al, Adv. Mater. 2011, 23, 998 ; N. Li et al, Adv. Funct. Mater. 2011, 21, 1717; H. Yang et al., J. Power Sources 2015, 288, 401; Y. Zhang et al. ACS Appl. Mater. Interfaces 2014, 6, 4458; M. Samiee et al., J. Power Sources 2014, 245, 594; W. Li et al., Chem. Mater. 2015, 27, 5014; J.-Y. Shin et al., J. Mater. Chem. Mater. 2012, 24, 543; M. Li et al., Electrochem. commun. 2015, 57, 43; M. Xie et al, J. Electrochem. Soc. 2015, 162, A974; H. Xiong et al., J. Phys. Chem. C 2012, 116, 3181; X. H. Wang et al., J. Mater. Chem. A 2015, 3, 15394.

[0141] The squares are anatase nanostructures; the diamonds are amorphous TiO₂; the circles are Anatase/C-composites; the triangles are doped anatase; the full star is TiO_{1.912}Cl_{0.088} according to an embodiment of the present invention; the hollow star is TTIP am-TiO₂ as prepared in the present disclosure. To compare the different nanostructures (thin-films, nanoparticles and nanotubes), the typical distance for Li-ion diffusion into these nanostructures was taken, which is: the film thickness for TiO₂ films, the radius for particles, half of the wall thickness for nanotubes. At a rate of 1C, our 100 nm amorphous TiO_{1.912}Cl_{0.088} film delivers 20% more capacity (301 mAh g⁻¹) than the best performing nanosized electrode (250 mAh g⁻¹ for am-TiO₂ nanotubes with 10 nm tube wall thickness). Furthermore, at 50 C, our amorphous TiO_{1.912}Cl_{0.088} achieves 92 mAh g⁻¹, still outperforming the nanosized based TiO₂ electrodes, except the am-TiO₂ nanotubes.

[0142] Without being bound by theory, our hypothesis for the enhanced capacity and excellent rate-performance is based on the enhancement of both the ionic and electronic conductivity. The enhanced electronic conductivity can be explained by permanent presence of Ti(III) states after substitution of O²⁻ by Cl⁻ in TiO₂. It is known that the presence of Ti(III) increases the electronic conductivity, which enhances the rate-performance

and in turn the accessible capacity. Note that the introduction of permanent Ti(III) by doping may go at the cost of maximum capacity. However, in our case, an increase in capacity was observed for up to 9% Ti(III) ($x \text{ Cl} = 0.088$) without any loss in accessible capacity. On the contrary, the maximum capacity was still increasing and exceeds that for complete reduction of Ti(IV) to Ti(III), especially when taking into account that only ~90% of the Ti is available as Ti(IV) (i.e. ~302 mAh g⁻¹ for Li_{0.9}TiO_{1.91}Cl_{0.09}). Under this assumption, about 17% of Ti(II) is formed at maximum capacity of 362 mAh g⁻¹. The ionic conductivity of Li⁺ is also known to be higher for amorphous TiO₂ than for crystalline TiO₂; Li-ion diffusion coefficients is of the order of $3.5 \times 10^{-12} \text{ cm}^2 \text{ s}^{-1}$ for amorphous and of the order of $\sim 1 \times 10^{-14} \text{ cm}^2 \text{ s}^{-1}$ for anatase. The fact that a significant fraction of Ti(II) can be formed indicates excellent access of Li⁺ ions in the Cl-doped material. The larger ionic radius of chloride compared to oxygen creates somewhat wider “channels” for Li⁺ to diffuse. Furthermore, the change in local ionic charge distribution might reduce the coulombic repulsion, enabling Ti(II) formation and lithium insertion of more than 1 Li⁺ per Ti.

[0143] Note that lithiation and delithiation mechanism for amorphous TiO₂ (and TiO_{2-y}Cl_y in our case) is different than for anatase TiO₂, which leads to absence of a “voltage plateau” for amorphous TiO₂ (see Fig. 11b). Such a plateau is typically the result of a first order phase transition between Li-rich and Li-poor domains. The amorphous structure likely suppresses such a transition from occurring and allows for a continuous insertion of Li⁺-ion across a wider potential range. In the case of anatase TiO₂, an orthorhombic Li_{0.6}TiO₂ phase is formed which leads to orders of magnitude decrease in the Li⁺-ion diffusion coefficient, blocking further lithiation. The disordered amorphous structure of TiO₂ likely allows for more facile Li⁺-ion diffusion as more random pathways are accessible within the material. It can be debated whether a sloped potential response is less desired than a potential plateau in full battery cell, but one benefit is the capability to determine the state of charge by directly measuring the cell voltage. Also, the average delithiation potential of TiO_{1.911}Cl_{0.088} is 1.65 V vs Li⁺/Li (measured at 1 C), which is 0.25 V below the delithiation potential of anatase TiO₂ (~1.9 V). Since titania is considered as negative electrode in the Li-ion battery, the lower delithiation potential will result in a higher energy density during discharge.

[0144] Demonstration of Cl-doped amorphous titanium oxide as 3D thin-film electrode

[0145] To enable small autonomous devices, integrated energy storage is needed that offers a small footprint and fast charging capabilities. A battery envisioned for this, is the three-dimensional (3D) all-solid-state thin-film battery. Key to its practical implementation, are cost-efficient conformal coating techniques and high rate-performance electrode materials. There are several benefits of integrating Cl-doped am-TiO₂ thin-films deposited by S-ALD in all-solid-state 3D batteries. First, the relatively low deposition temperature (<150 °C) is advantageous for fabrication of a full 3D battery stack, as it prevents crystallization or oxidation of underlying layers or current collector. For example, the amorphous LIPON solid-electrolyte crystallizes above 360 °C, which leads to orders of magnitude decrease in the room temperature ionic conductivity and must therefore be prevented. Second, absence of crystallites for Cl-doped am-TiO₂ gives rise to smooth layers which ensure a good interface with the solid-electrolyte and integrity of the whole stack. Last, S-ALD offers a unique opportunity to deposit high-quality and self-limiting films at much higher deposition rates than conventional ALD. To demonstrate Cl-doped am-TiO₂ deposited by s-ALD as a 3D thin-film electrode, 100 nm TiO_{2-y}Cl_y was deposited on TiN-coated silicon micropillars. The Si micropillars were fabricated by photolithographic patterning and deep reactive ion etching and are arranged in a square lattice. The pillars are about 50 μm tall and have a diameter and spacing of 2 μm, as shown in the SEM micrographs of Fig 13a-c. Fig 13a is a top-view of uncoated pillars; Fig

13b is a tilted-top view of Cl-doped amorphous titanium oxide coated pillars and Fig. 13c is a cross-section images thereof. The inset shows a digital photograph image of the 1 x 1 cm² Si micropillar array.

[0146] The 3D structure offers an area enhancement factor (AEF) of about 21 to 25x on which different TiO_{2-y}Cl_y s-ALD deposition conditions were tested.

5 **[0147]** Fig 14 gives the electrochemical results of planar (2D) and microstructured (3D) TiO_{2-y}Cl_y electrodes in 1 M LiClO₄ in PC deposited at different deposition conditions. Fig 14a shows the cyclic voltammograms recorded at 10 mVs⁻¹ for the 2D and 3D electrodes deposited at 100 °C and 70 ms exposure time which corresponds to a composition of TiO_{1.912}Cl_{0.088} for the planar substrates. The shape of the reduction and oxidation peaks for the 3D sample are similar to that of the planar sample (see also Fig. 11a). The peak potentials
10 are somewhat shifted as expected for the larger ohmic drop. The peak current density of the 3D electrode shows a 30-fold increase compared to the planar one, which is in range of what is expected only from the area enhancement.

[0148] Fig 14b shows the capacity-potential profiles for the 2D and 3D electrodes measured at constant current of 1 C (9 and 200 μA cm⁻² for 2D and 3D, respectively). To easily compare the lithiation and delithiation
15 characteristics, the measured capacities are normalized by their respective maximum delithiation capacities reached at the cut-off of 3.0 V and measured at 0.25 C. The good matching of the potential profiles for the 2D and 3D electrodes, indicates that the 3D coating is similar in thickness and Cl-content. Fig. 14c compares the (delithiation) footprint capacities of 2D and 3D TiO_{2-y}Cl_y electrodes with y = 0.088 and y = 0.074 at different C-rates. The highest footprint capacity is again found for the highest Cl content; a footprint capacity of 242 and 164
20 μAh cm⁻² is reached at 0.25 C for y = 0.088 and y = 0.074, respectively. For both Cl contents, the capacity of the 3D electrodes is exactly 24 times that of the 2D electrode, in line with the AEF. Moreover, the 3D electrodes have the same trend in capacity against C-rate as the planar electrodes, showing that the rate performance is comparable as expected for the same film thickness. Specifically, the best performing 3D electrode (TiO_{1.912}Cl_{0.088}) can access 87% (211 μAh cm⁻²) and 37% (89 μAh cm⁻²) of its maximum capacity at 1 and 20 C,
25 respectively. This is similar to the percentage of accessible capacity for the planar sample and shows that the planar capacity can effectively be enhanced by 3D structuring, while preserving the same rate-performance.

[0149] The cycling stability of the 3D TiO_{1.912}Cl_{0.088} electrode was investigated for over 1000 constant current lithiation/delithiation cycles (not shown). First, a rate of 10 C was applied for 1000 cycles, after which 1 C was applied for 5 cycles. A cut-off potential of 3.0 and 0.1 V vs Li⁺/Li was used for the constant current
30 experiments. For the first 30 cycles (at 10 C), the footprint capacity increased slightly from 133 μAh cm⁻² to about 140 μAh cm⁻², and remained constant for the subsequent 970 cycles. Hence, no loss in capacity during 1000 cycles at 10 C is observed for the Cl-doped amorphous TiO₂ films. The average delithiation/lithiation coulombic efficiency for the complete cycling experiment was 99.96%. The first cycle measured at 10 C had a coulombic efficiency of 83.4%, and the first cycle at 1 C had a coulombic efficiency of 111.2%. This suggests
35 that during the first cycle, a certain amount of lithium was trapped which was later recovered at a lower C-rate. Hence, the 3D Cl-doped TiO₂ electrode can reversibly insert/extract lithium for over 1000 cycles with no loss in capacity and high coulombic efficiency.

[0150] Comparison of the 3D Cl-doped amorphous titanium oxide electrodes with TiO₂ thin-film electrodes found in the literature.

40 **[0151]** To benchmark our best performing 3D TiO_{2-y}Cl_y electrode, we compared its rate-performance with 3D TiO₂ thin-film electrodes found in literature. Specifically, we chose 3D current collector designs which have

a periodic structure with sufficient spacing for conformal deposition of the complete thin-film battery stack (both positive and negative electrodes separated by solid-state-electrolyte). For this reason, reports on, for example, TiO₂/carbon composites, or TiO₂-coated nanoporous Au have been omitted. Fig 15 summarizes the capacities obtained for TiO₂ thin-film electrodes on silicon micropillars (J. Xie et al, J. Electrochem. Soc. 2016, 163, A2385), silicon microtubes (E. Eustache et al., Adv. Energy Mater. 2014, 4, 1301612 ; M. Létiche et al., Adv. Energy Mater. 2016, 201601402, 1601402) and aluminum nanorods (S. K. Cheah, Nano Lett. 2009, 9, 3230), conformal deposited by ALD (E. Eustache et al; M. Létiche et al.; S.K. Cheah et al.) and CVD (J. Xie et al.). Note that the CVD anatase films of J. Xie et al. were deposited on the same Si micropillar arrays as used in this work. Three different properties related to the electrode performance have been examined: (1) the footprint capacity, (2) the active material capacity and (3) the 3D electrode volumetric capacity.

[0152] The circles stand for a 150 nm TiO₂ anatase deposited by ALD on Si microtubes (E. Eustache et al.); the squares stand for 40 nm TiO₂ anatase deposited by LPCVD on Si micropillars (J. Xie et al.); the stars stand for 155 nm TiO₂ anatase/LIPO deposited by ALD on Si microtubes (M. Létiche et al.); the diamonds stand for 17 nm TiO₂ anatase/amorphous deposited by ALD on Al nanorods (S. K. Cheah et al.); and the circles stand for 100 nm Cl-doped amorphous titanium oxide on Si micropillars according to an embodiment of the present invention.

[0153] Fig. 15a compares the footprint capacity of the different 3D TiO₂ thin-film electrodes at different C-rates (taken as reported). At the low rate of 0.06 C, the highest footprint capacity of 370 $\mu\text{Ah cm}^{-2}$ is obtained for Si microtube arrays coated with a Pt current collector and 155 nm anatase TiO₂/Li₃PO₄ (LIPO). The reported Si microtube structure gives an AEF of about 53x which corresponds with an “equivalent” TiO₂ thickness of around 8.2 μm and is over four times that of our 3D TiO₂ on Si micropillar arrays (AEF ~21x and effective film thickness of 100 nm). However, a high footprint capacity and fast charging is very advantageous for applications where the surface area for energy storage is limited and recharge needs to be quick, for example in health monitoring devices. Indeed, a main advantage claimed for 3D thin-film batteries is their fast charging capability. As shown in Fig. 15a, above 1 C however, the capacity of the 3D Si microtube-based electrodes fades quickly and retain less than 10 $\mu\text{Ah cm}^{-2}$ for C-rates higher than 10 C. In contrast, our fast kinetics 3D Cl-doped am-TiO₂ electrodes retains a footprint capacity larger than 100 $\mu\text{Ah cm}^{-2}$ up to 10 C; i.e. at least 10 times better than all other 3D TiO₂ electrodes.

[0154] Fig. 15b gives the volumetric capacities (capacity per active material volume) of the TiO₂ active material for different C-rates. This value was obtained by dividing the footprint capacity by the equivalent TiO₂ thickness (= AEF x effective TiO₂ film thickness). Across all C-rates, our 3D TiO_{1.912}Cl_{0.088} electrode delivers the highest volumetric capacity. This high volumetric capacity explains why a thinner TiO₂ film (100 nm TiO_{1.912}Cl_{0.088} versus 155 nm anatase) on a 3D structure with only half the area enhancement (AEF of 21x versus 53x) still had similar footprint capacity.

[0155] Finally, we also analyzed the volumetric capacity of the complete 3D architecture denoted as “3D electrode capacity”. This value was obtained by dividing the footprint capacity by the pillar or microtube height. The 3D electrode capacity gives an indication of the volumetric capacity of the final energy storage device (disregarding packaging and substrate support). A successful 3D electrode design will maximize the volume of the Li⁺-ion insertion material while minimizing the volume of the 3D current collectors (and solid-state electrolyte). Fig. 15c shows the 3D electrode capacity for the different 3D TiO₂ electrodes. At a low C-rate of 0.08 C, the best 3D electrode capacity (57 mAh cm⁻³) is obtained for the Si microtube electrode coated with 150

nm anatase TiO_2 (AEF of 25x). However, similar to the results from Fig. 15a–b, from the rate of 0.25 to 25 C, the 3D amorphous $\text{TiO}_{2-y}\text{Cl}_y$ electrode has the highest 3D volumetric capacity.

5 **[0156]** The foregoing description details certain embodiments of the disclosure. It will be appreciated, however, that no matter how detailed the foregoing appears in text, the disclosure may be practiced in many ways. It should be noted that the use of particular terminology when describing certain features or aspects of the disclosure should not be taken to imply that the terminology is being re-defined herein to be restricted to including any specific characteristics of the features or aspects of the disclosure with which that terminology is associated.

CLAIMS

1. A negative electrode of an ion insertion battery cell (100) comprising a negative electrode layer (14) comprising a titanium oxide comprising chlorine being either amorphous or a mixture of an amorphous titanium oxide comprising chlorine and a crystalline titanium oxide comprising chlorine.
- 5 2. The negative electrode according to claim 1 wherein the ratio chlorine to titanium in the negative electrode layer (14) is from 0.01 to 0.1, preferably from 0.06 to 0.09, when measured by Rutherford Backscatter Spectroscopy.
3. The negative electrode according to claim 1 wherein the titanium oxide comprising chlorine has for general formula $\text{TiO}_{2-y}\text{Cl}_y$ wherein y is from 0.01 to 0.1, preferably from 0.06 to 0.09.
- 10 4. The negative electrode according to any of the previous claims wherein the thickness of the negative electrode layer (14) is in the range between 5 nm and 2 micrometer.
5. The negative electrode according to any of the previous claims wherein the negative electrode layer (14) is a thin-film electrode layer.
6. The negative electrode according to any of claims 1 to 5 wherein the negative electrode layer (14) is a particle based electrode layer.
- 15 7. An ion insertion battery cell (100) comprising a negative electrode according to any of the previous claims.
8. An ion insertion battery comprising at least one ion insertion battery cell according to claim 7.
9. A method for forming a negative electrode in accordance with any of claims 1 to 6, wherein the method comprises depositing a thin film of titanium oxide comprising chloride on a substrate (10) by performing an
- 20 Atomic Layer Deposition process using TiCl_4 and H_2O precursors at a deposition temperature in the range between 50°C and 150°C, the titanium oxide comprising chlorine being either amorphous or a mixture of an amorphous titanium oxide comprising chlorine and a crystalline titanium oxide comprising chlorine.
10. The method according to claim 9 wherein depositing the thin film comprises depositing the thin film on a non-planar substrate (10).
- 25 11. A method for fabricating an ion insertion battery cell wherein the method comprises forming an electrode according to any of claims 9 or 10.
12. The method for fabricating an ion insertion battery cell according to claim 11, wherein forming the negative electrode comprises depositing the negative electrode layer (14) on a layer stack comprising a first positive electrode layer (12) and an electrolyte layer (13).
- 30 13. A method for fabricating an ion insertion battery comprising at least one ion insertion battery cell, the method comprising fabricating the at least one ion insertion battery cell by a method according to any of claims 11 or 12.
14. A negative electrode obtainable by depositing a thin film of titanium oxide comprising chlorine on a substrate (10) by performing an Atomic Layer Deposition process using TiCl_4 and H_2O precursors at a deposition
- 35 temperature in the range between 50°C and 150°C, the titanium oxide comprising chlorine being either amorphous or a mixture of an amorphous titanium oxide comprising chlorine and a crystalline titanium oxide comprising chlorine.
15. Use of a layer of titanium oxide comprising chlorine in an ion insertion electrode, wherein the titanium oxide comprising chlorine is either amorphous or a mixture of an amorphous titanium oxide comprising chlorine
- 40 and a crystalline titanium oxide comprising chlorine.

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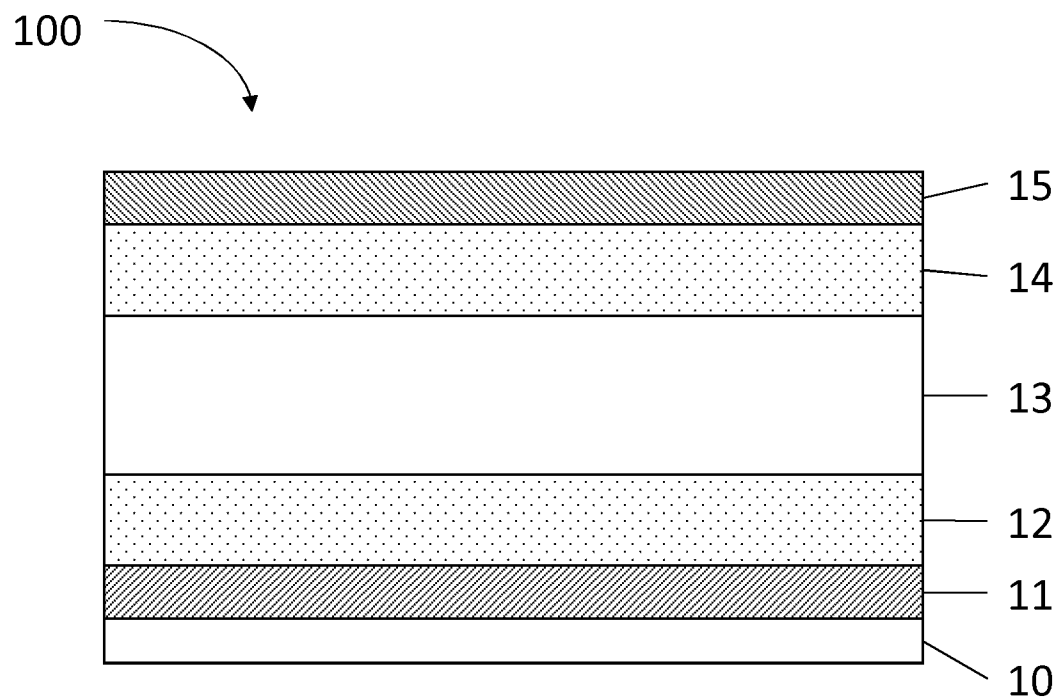


FIG 1

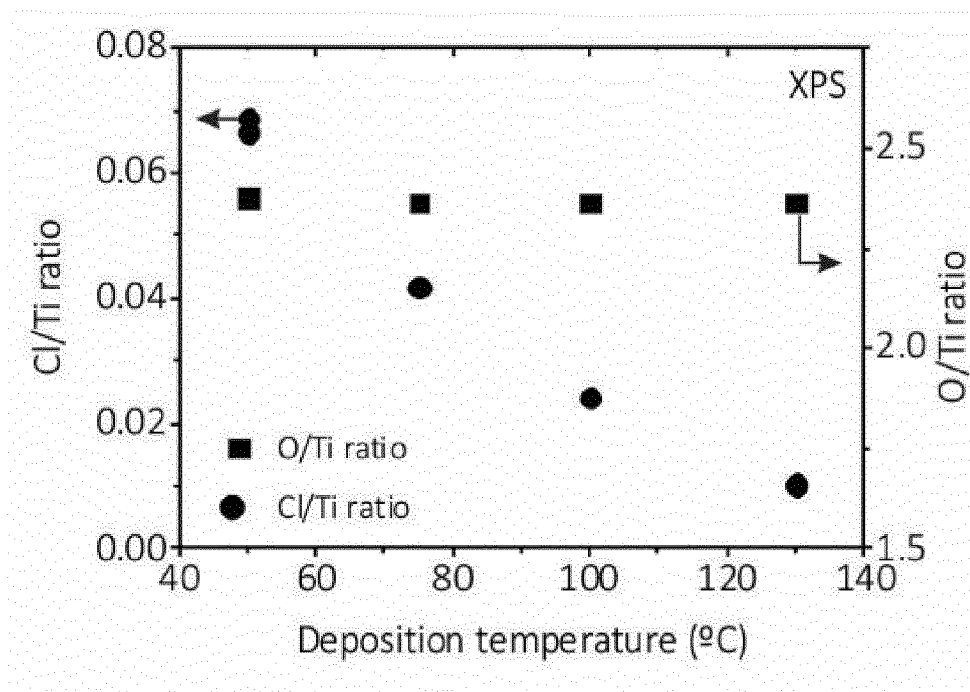


FIG 2

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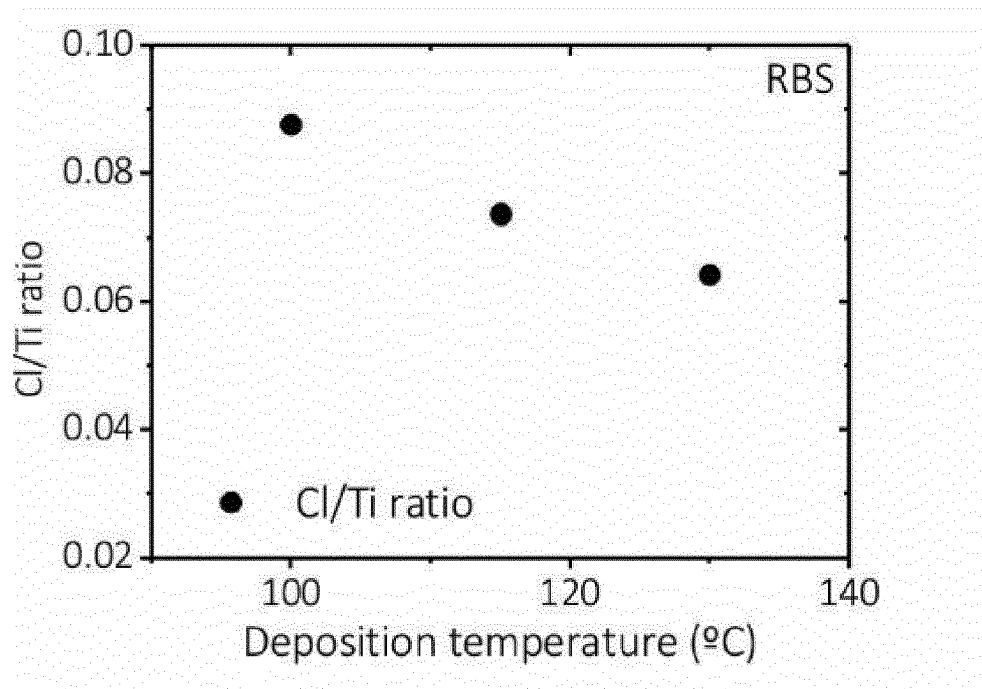


FIG 3

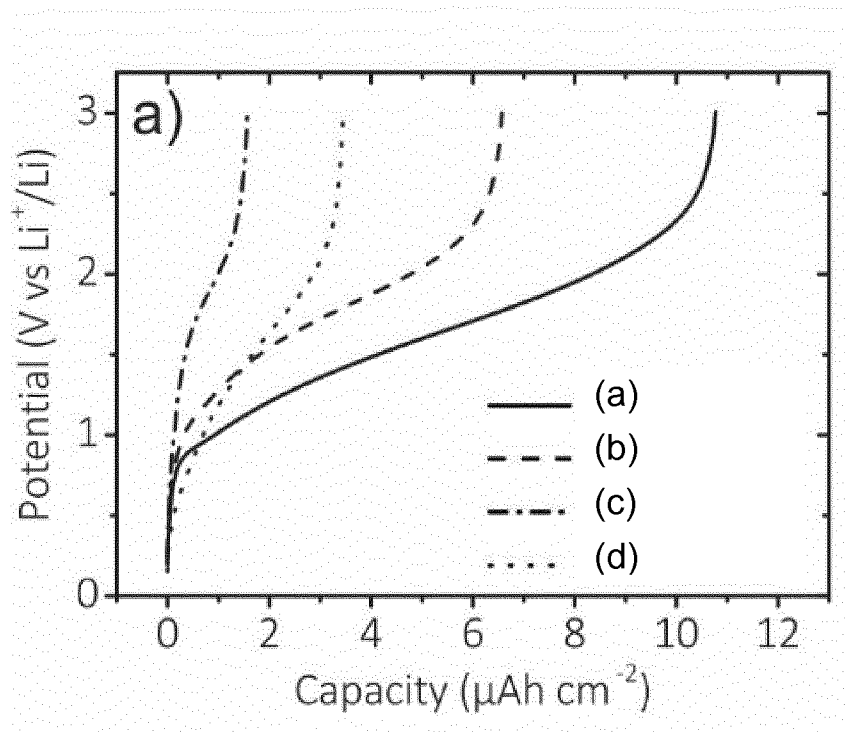


FIG 4

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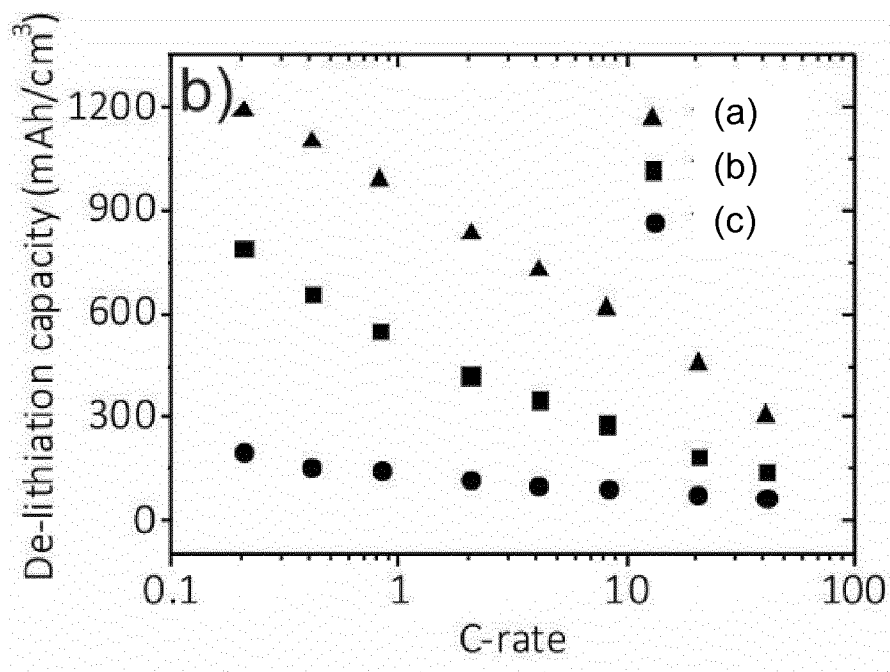


FIG 5

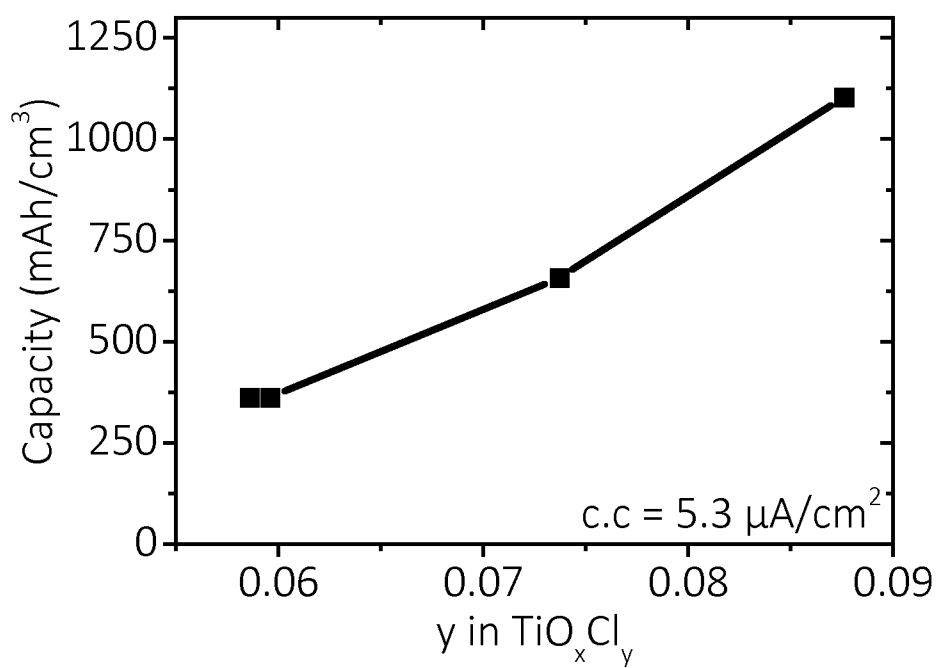


FIG 6

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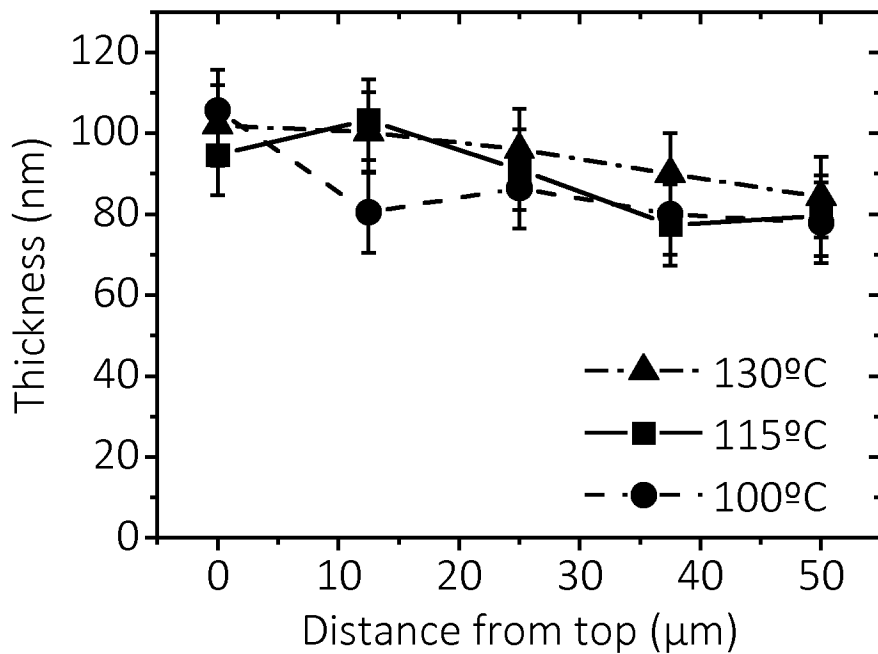


FIG 7

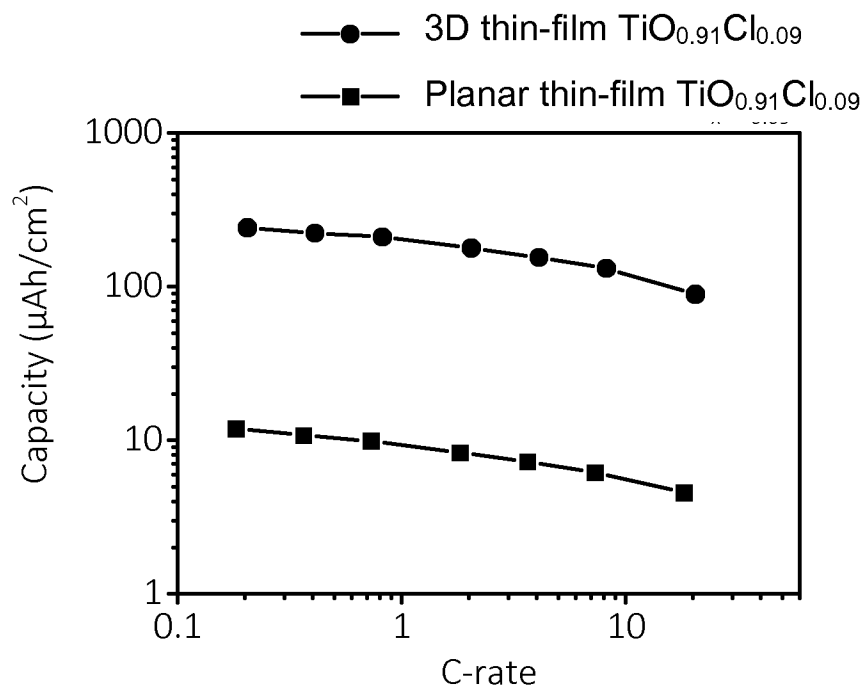


FIG 8

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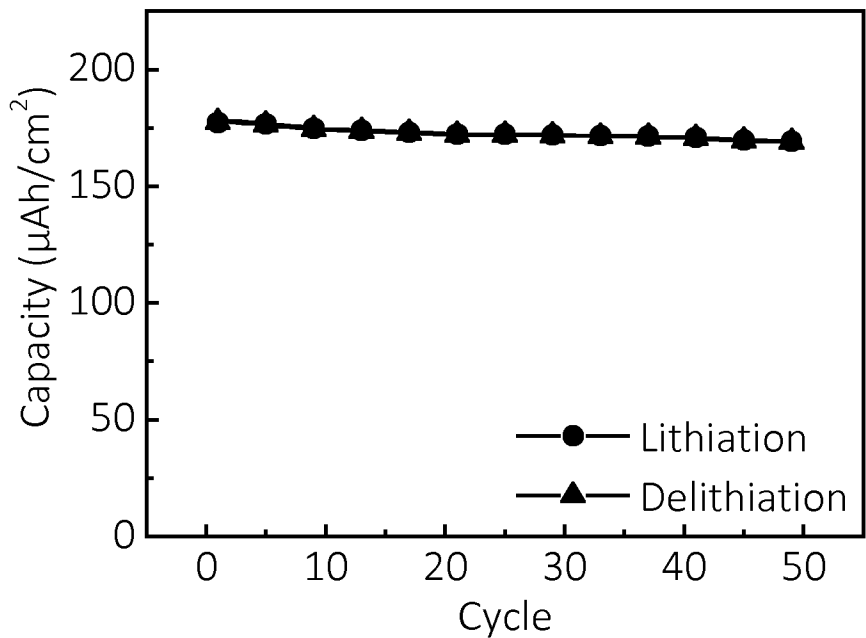


FIG 9

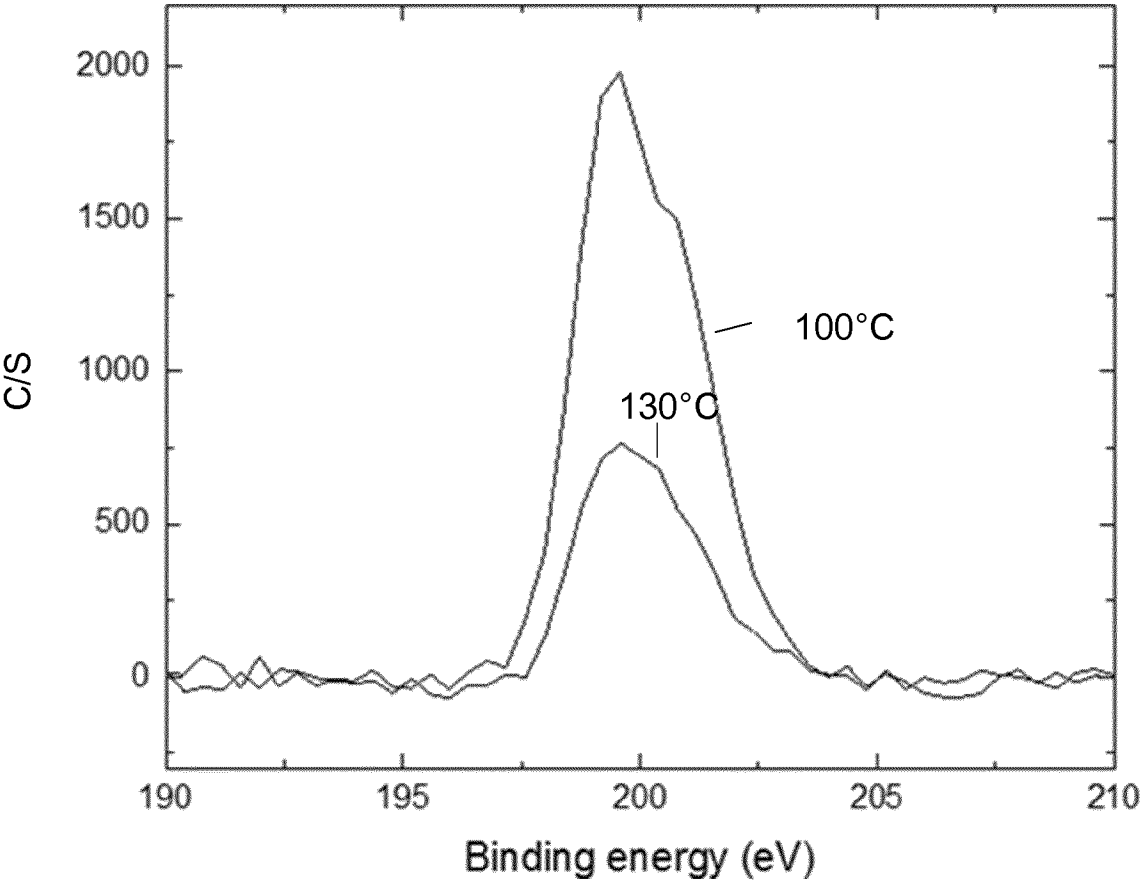


FIG 10

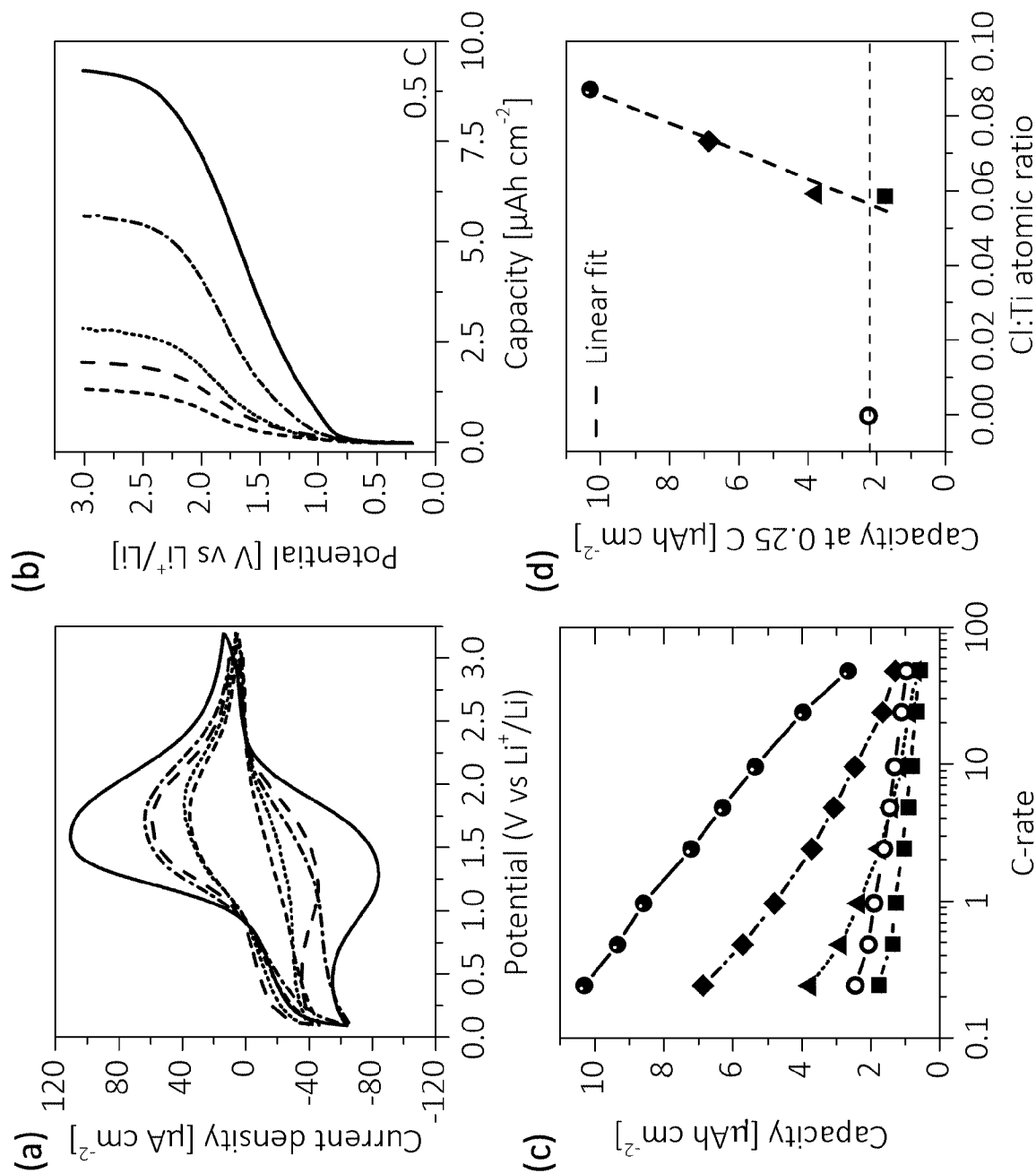


Fig 11

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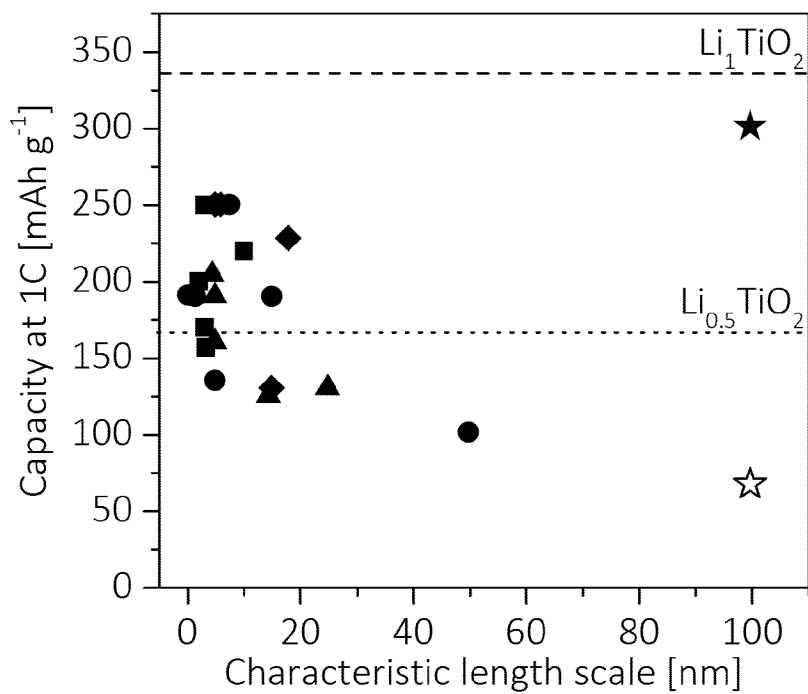


Fig 12

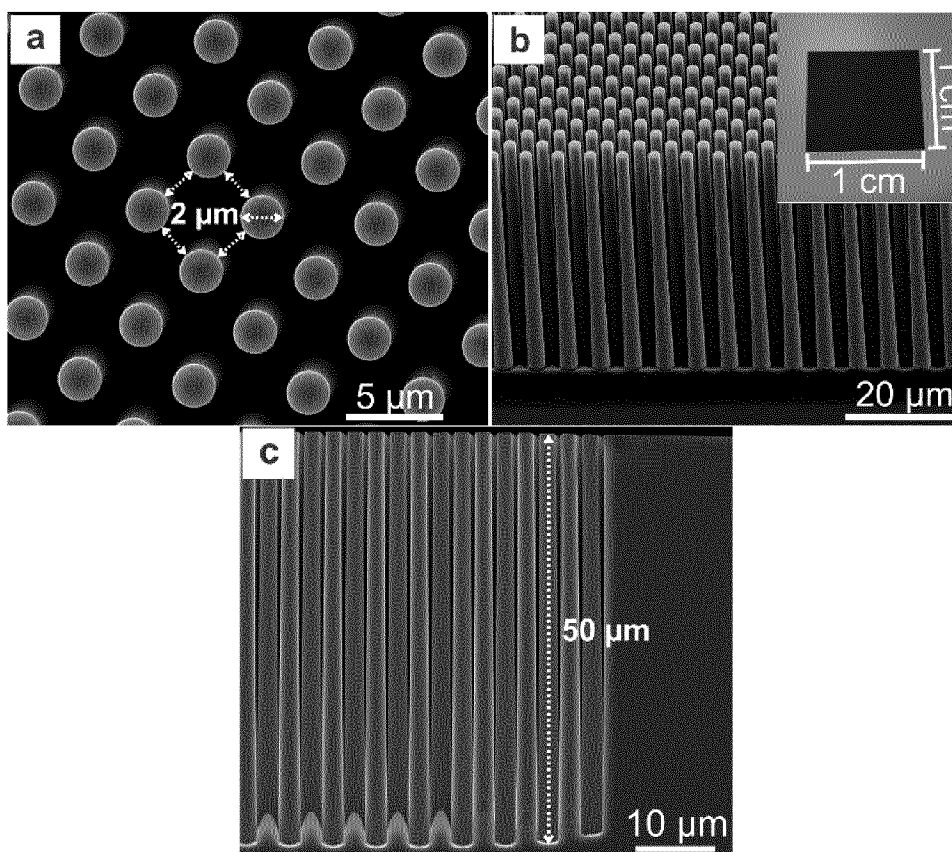


Fig 13

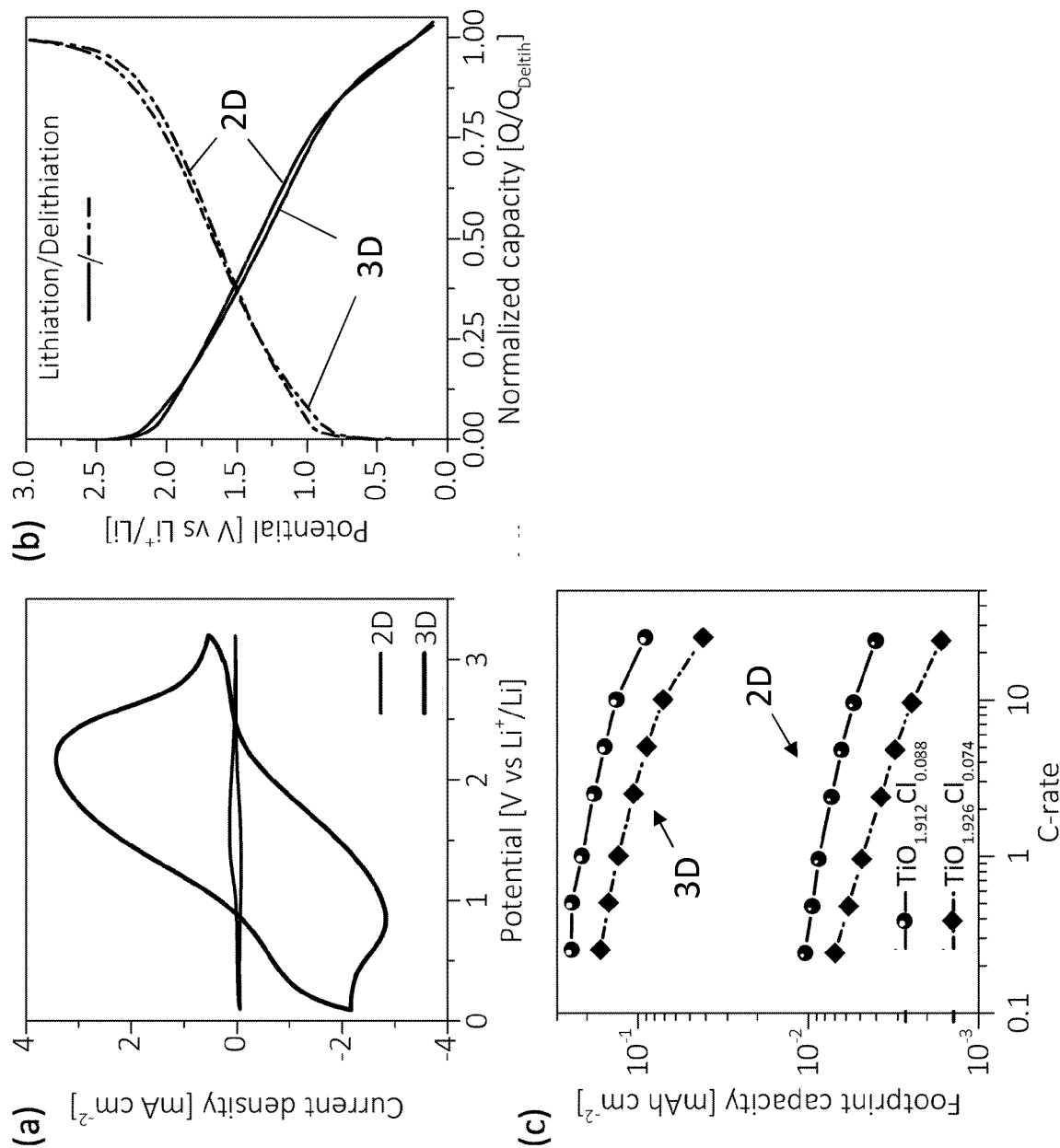


Fig 14

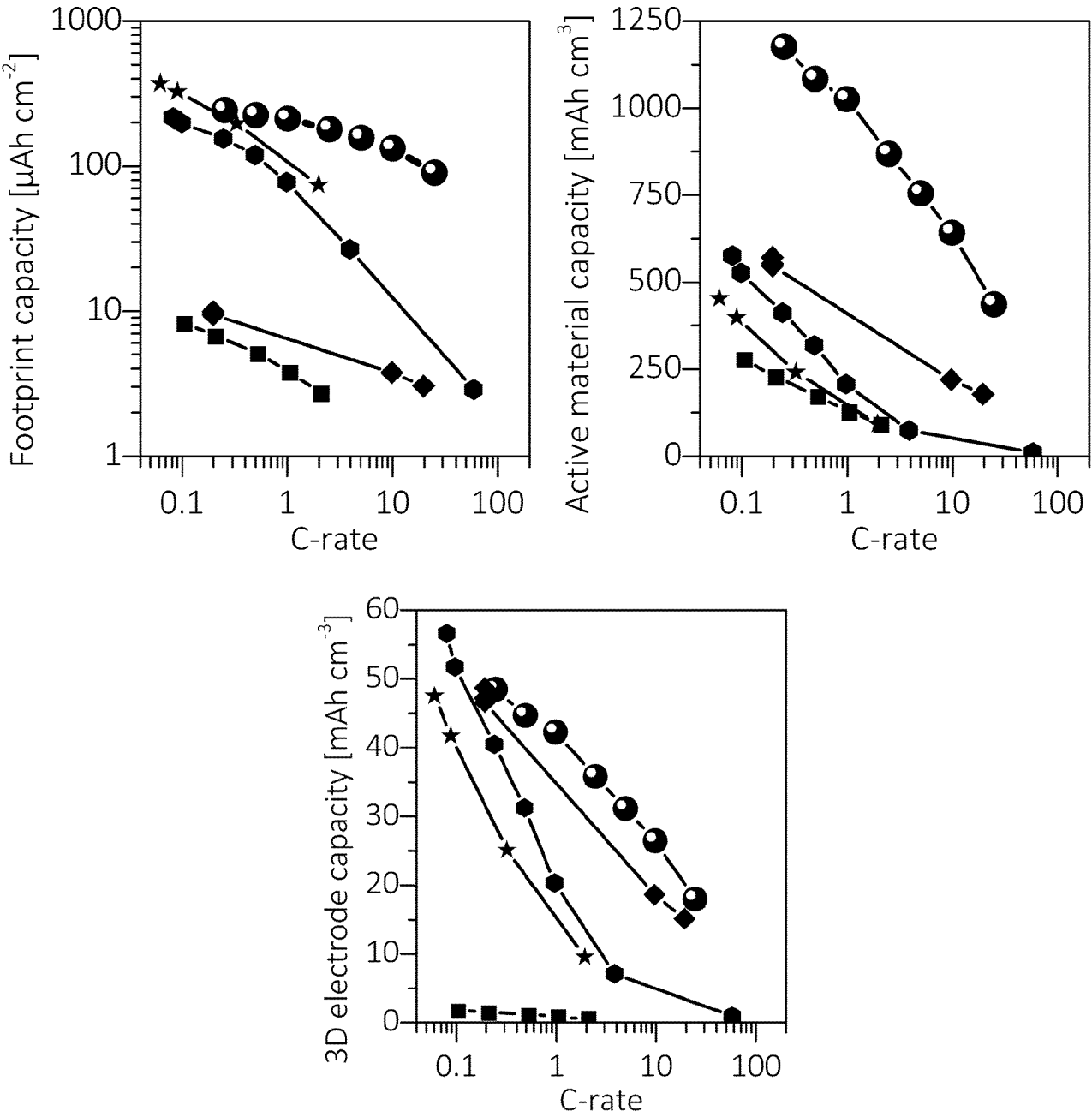


Fig 15

INTERNATIONAL SEARCH REPORT

International application No

PCT/EP2017/066417

A. CLASSIFICATION OF SUBJECT MATTER

INV. H01M4/04 H01M4/1315 H01M4/13915 H01M4/485 H01M10/0525
 H01M10/0562 C01G23/07
 ADD. H01M6/40

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

H01M C01G

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

EPO-Internal, WPI Data

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X	CHUNMEI BAN ET AL: "Atomic layer deposition of amorphous TiO ₂ on graphene as an anode for Li-ion batteries", NANOTECHNOLOGY, IOP, BRISTOL, GB, vol. 24, no. 42, 25 September 2013 (2013-09-25), page 424002, XP020252095, ISSN: 0957-4484, DOI: 10.1088/0957-4484/24/42/424002 [retrieved on 2013-09-25]	1,5,7,9, 11,12, 14,15
Y	abstract page 2, left-hand column, lines 21-23, 55-56 page 2, left-hand column, lines 55-56 page 3, right-hand column, lines 4-8, 17-18 page 4, right-hand column, lines 15-40 page 5, right-hand column, lines 37-38 ----- -/-	9-13



Further documents are listed in the continuation of Box C.



See patent family annex.

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Date of the actual completion of the international search

9 October 2017

Date of mailing of the international search report

17/10/2017

Name and mailing address of the ISA/

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Authorized officer

Gregori, Giuliano

INTERNATIONAL SEARCH REPORT

International application No
PCT/EP2017/066417

C(Continuation). DOCUMENTS CONSIDERED TO BE RELEVANT		
Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
Y	US 2011/052994 A1 (HARADA YASUHIRO [JP] ET AL) 3 March 2011 (2011-03-03) abstract paragraphs [0023], [0024], [0031], [0037], [0042], [0043], [0047], [0064] table 1 Example 1-9	1-15
Y	----- HAI-TAO FANG ET AL: "Comparison of the rate capability of nanostructured amorphous and anatase TiO ₂ for lithium insertion using anodic TiO ₂ nanotube arrays", NANOTECHNOLOGY., vol. 20, no. 22, 13 May 2009 (2009-05-13), page 225701, XP055404554, GB ISSN: 0957-4484, DOI: 10.1088/0957-4484/20/22/225701 abstract figure 4	1-8,15
Y	----- AARIK ET AL: "Effect of crystal structure on optical properties of TiO ₂ films grown by atomic layer deposition", THIN SOLID FILMS, ELSEVIER-SEQUOIA S.A. LAUSANNE, CH, vol. 305, no. 1-2, 1 August 1997 (1997-08-01), pages 270-273, XP005278609, ISSN: 0040-6090, DOI: 10.1016/S0040-6090(97)00135-1 figure 2 page 270, right-hand column, lines 17-20 page 271, left-hand column, lines 38-45	5,14
Y	----- US 2015/086809 A1 (LEMKE MARKO [DE] ET AL) 26 March 2015 (2015-03-26) paragraphs [0003], [0027], [0121] figures 4I, 4M -----	10

INTERNATIONAL SEARCH REPORT

Information on patent family members

International application No

PCT/EP2017/066417

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